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High Temperature Stability of Binary Microstructures Derived From Liquid Precursors

Contract AFOSR-91-0125

Final Report

June 30, 1994

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Materials Department College of Engineering University of California Santa Barbara, CA 93106

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Principal Investigator: Fred F. Lange

1. Background

This program has emphasized two topics: 1) the crystallization of metastable, solid-solution structures, their partitioning into equilibrium structures and compositions, and the role of the metastable phase and its partitioning on forming unique, nanometer microstructures important to the mechanics of structural ceramics and their composites, and 2) the formation of single crystal thin films via spin coating single crystal substrates with solution precursors. Results for the first topic are new, namely, the discovery that diffusion limited crystallization concepts used in rapid solidification directly applies to precursors that crystallize at low temperatures during heating. This discovery is significant because solid-solutions can be greatly extended relative to high temperature synthesis and processing routes where equilibrium conditions are rapidly achieved and solid-solutions can be severely limited. Extension of solid-solution fields (and thus defect chemistries) in compositional space is important to synthesize new materials with optical and electronic properties controlled by defect chemistry and/or metastable compositions. Results for the second topic have shown that single crystal thin films can be formed on single crystal substrates with spin-on liquid precursors despite large differences in lattice parameters and/or crystal structures. Several mechanisms have been identified for the growth of single crystal thin films which are very different to the well know vapor phase epitaxy mechanisms. The significance of the second topic is that single crystal (or poly-variant single crystal) thin films of nearly any inorganic material can be produced on any non-reactive (thermodynamically or kinetically) single crystal substrate, despite crystal structure differences between the film and substrate materials. Processing of multi-layer and/or embedded strip line architectures are possible using liquid precursor spin-on techniques for new device technologies.

- 2. Summary of acceearch for Last Period
- 2.1 Kinetic Limited Crystallization and Phase Partitioning with Solution Precursors
- 2.1.1 Development of Nano-Composite Microstructures in ZrO₂-Al₂O₃ Via the Solution Precursor Method, Mari Lou Balmer, Fred F. Lange, Vikram Jayaram and Carlos G. Levi

Technical Report No. 10

Abstract: Aqueous mixtures \mathcal{L} 2001 Dilum acetate and aluminum nitrate were pyrolyzed and crystallized to form a metastable solid solution, $Zr_{1-x}Al_xO_{2-x/2}$ ($x \le 0.57$). The initial, metastable phase partitions at higher temperatures to form two metastable, viz., t-($Zr_{1}Al_{1}O_{2} + \gamma_{1}(Al_{1}Zr_{1})$ 203 with a nano-scale microstructure. The microstructural observations associated with the $\gamma \to \alpha$ -Al₂O₃ phase transformation in the t- $Zr_{1}O_{2}$ matrix are reported for compositions containing 16, 20 and 40 mol% Al₂O₃. During this phase transformation the α -Al₂O₃ grains take the form of a colony of irregular, plate-like grains, all with a common crystallographic orientation, containing $Zr_{1}O_{2}$ inclusions and separated by $Zr_{1}O_{2}$ grains. At lower volume fractions of Al₂O₃, the colonies coarsen to single, irregular plates, surrounded by polycrystalline $Zr_{1}O_{2}$. The heat treatment condition also controls the microstructure. Interpenetrating microstructures produced at high volume fractions of Al₂O₃ exhibit very little grain growth for periods up to 24h at 1400 °C.

2..1.2 ²⁷Al NMR of Zr_(1-x)Al_xO_(2-x/2) Solid Solutions Synthesized with Solution Precursors, Mari Lou Balmer, Nandini Das, Hellmut Eckert, and Fred F. Lange

Technical Report No. 11

Abstract: The local environment of the aluminum atoms in a series of metastable $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions (0.08 $\leq x \leq$ 0.57), prepared by diffusion-limited crystallization of amorphous precursors, has been determined by ²⁷Al magic-angle spinning (MAS) NMR. Results show the existence of aluminum in 4-, 5-, and 6-fold coordination in both the amorphous and crystalline states. While the relative amounts of each type of coordination show no compositional dependence in the amorphous state, the results for the crystalline materials show a systematic decrease in the average Al coordination number with increasing Al content. Comparisons of MAS NMR results between pure Al₂O₃ precursors and $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions processed under the same conditions show a profound effect of zirconia on the coordination environment of the Al atom. Both a random distribution model and a model which assumes small scale clustering of Al ions are considered to explain the trends in the type of Al coordination as a function of composition.

2.2 Single Crystal Thin Films via Solution Precursor Routes

2.2.1 Epitaxial Growth of PbTiO₃ Thin Films on {100} SrTiO₃ from Solution Precursors Andreas Seifert, Fred F. Lange and James S. Speck

Technical Report No. 12

Abstract: A mixed alkoxide liquid precursor was used to form epitaxial PbTiO₃ thin films by spin-coating on cubic (001) SrTiO₃ substrates. The films were heat-treated at temperatures between 380°C and 800°C. X-ray diffraction, atomic force microscopy, scanning and transmission electron microscopy were used to characterize the microstructure of the films and to evaluate the epitaxial phenomena. At ~ 400°C a polycrystalline, metastable fluorite crystallizes from the amorphous, pyrolyzed precursor. At slightly higher temperatures (~420°C) the thermodynamically stable perovskite phase epitaxially nucleates at the film/substrate interface. A small number of epitaxial grains grows through the film toward the surface, consuming the nanometer-size, polycrystalline grains with the fluorite structure. Grain coarsening leads to a reduction in mosaic spread during further heating. Pores that concurrently coarsen, produce a pitted surface as they disappear from within the epitaxied film. At 800°C a dense, epitaxied PbTiO₃ film with a smooth surface is observed. Parameters governing the formation of a- and c-domains are discussed as well as the small tilts of the domain axes away from the substrate normal.

High Temperature Stability of Binary Microstructures Derived From Liquid Precursors

Contract AFOSR-91-0125

Technical Report No. 10

Development of Nano-Composite Microstructures in ZrO₂-Al₂O₃ Via the Solution Precursor Method

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Final Report June 30, 1994 Principal Investigator: Fred F. Lange 805 893 8248

Submitted to the Journal of the American Ceramic Society

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^b Visiting from the Indian Institute of Science, Bangalore, India

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Abstract

Aqueous mixtures of zirconium acetate and aluminum nitrate were pyrolyzed and crystallized to form a metastable solid solution, $Zr_{1-x}Al_xO_{2-x/2}$ (x \leq 0.57). The initial, metastable phase partitions at higher temperatures to form two metastable phases, viz., t- $(Zr,Al)O_2 + \gamma$ - $(Al,Zr)_2O_3$ with a nano-scale microstructure. The microstructural observations associated with the $\gamma \to \alpha$ - Al_2O_3 phase transformation in the t- ZrO_2 matrix are reported for compositions containing 10, 20, and 40 mol% Al_2O_3 . During this phase transformation the α - Al_2O_3 grains take the form of a colony of irregular, plate-like grains, all with a common crystallographic orientation. The plates contain ZrO_2 inclusions and are separated by ZrO_2 grains. The volume fraction of Al_2O_3 and the heat treatment conditions influence the final microstructure. At lower volume fractions of Al_2O_3 , the colonies coarsen to single, irregular plates, surrounded by polycrystalline ZrO_2 . Interpenetrating microstructures produced at high volume fractions of Al_2O_3 exhibit very little grain growth for periods up to 24 hours at 1400 °C.

^a Now at Battelle Pacific Northwest Laboratories, Richland, WA

b Visiting from the Indian Institute of Science, Bangalore, India

1. Introduction

Previous studies by the authors 1 have shown that aqueous mixtures of zirconium acetate and aluminum nitrate pyrolyze and crystallize to a metastable, single phase solid-solution over the compositional range described by t-Zr(1 $x)Al_xO_{(2-x/2)}$ (x\le 0.57). When 0.57 < x < 0.67, the crystallization temperature is sufficiently high so that crystallization and partitioning occur concurrently, resulting in two phase $t-(Zr,Al)_2 + \gamma-(Al,Zr)_2O_3$. In all cases an amorphous solid is first produced during pyrolysis, and crystallization to the metastable phase occurs at a temperature which increases with the Al₂O₃ content. The grain size of the initial, metastable crystalline phase is ≈ 3 to 5 nm. When diffusional constraints are relieved by heating to higher temperatures or by holding at temperature for long periods, all single phase crystalline compositions (≤ 40 mol% Al₂O₃) partition into a nano-crystalline (grain size = 20-100 nm), two-phase material, $t-(Zr,Al)O_2 + \gamma$ -(Al,Zr)₂O₃. These two-phase microstructures were shown to be extremely stable at temperatures ≤ 1000°C, maintaining grain sizes of less than 100 nm for up to 100 hours at 1000°C. After long periods at high temperatures (≥ 1300°C) all compositions reach their equilibrium phase assemblage, $t-ZrO_2 + \alpha-Al_2O_3$.c

The present paper describes the microstructural development that occurs when metastable, nano-crystalline γ -Al₂O₃ transforms to α -Al₂O₃ within the zirconia matrix. It will be shown that unique two phase microstructures are produced, which are stable at high temperatures. The microstructural features of these composite materials may be desirable for producing materials with potentially interesting mechanical properties.

In order to better understand the $\gamma \to \alpha$ -Al₂O₃ transformation in a ZrO₂ matrix, it is first convenient to review the phase transitions that are known to occur

^c Some t-ZrO₂ grains transform to m-ZrO₂ on cooling

in single phase Al_2O_3 . It is well known that there are a number of metastable polymorphs of aluminum oxide which exist in addition to the thermodynamically stable α - Al_2O_3 . The most commonly reported transformation sequence is:²⁻⁵

amorphous
$$\rightarrow \gamma \rightarrow \delta \rightarrow \theta \rightarrow \alpha$$
 -Al₂O₃.

The crystal structures of these common polymorphs are: γ^d (cubic spinel), δ (orthorhombic)⁶, θ (monoclinic), and α (rhombohedral). The oxygen ions are in a cubic close packed (ccp) arrangement in the γ , δ , and θ structures and in a hexagonal close packed (hcp) arrangement in the α structure. Cation ordering within the ccp based structures gives rise to the different metastable polymorphs. The initial alumina polymorph and the transformation sequence has been reported to depend on the precursor chemistry and the characterization technique.^{2,3,5} Precise characterization of the metastable phases is often difficult due to the fact that many of the these phases produce broad x-ray diffraction spectra (XRD) which are distinguished from one another by weak diffraction peaks.

2. Experimental Procedure

Compositions were prepared as aqueous solutions containing aluminum nitrate hydrate e and zirconium acetate f, such that the pyrolyzed product would contain 10, 20 and 40 mol% Al₂O₃. To avoid the selective crystallization of the aluminum nitrate during solvent removal, the solutions were atomized onto a Teflon coated, aluminum substrate at 250 °C to yield a powder which was amorphous by x-ray diffraction analysis (XRD) and electron diffraction. The powders were then heated in a furnace at a rate of 10 °C/min., or upquenched to

 $^{^{}m d}$ Also identified in the literature as η

e Fisher Scientific reagent grade aluminum nitrate hydrate

f Chemical composition by ICP mass spectroscopy in ref #7

temperatures ranging from 900 °C to 1400 °C. Upquenching was achieved by placing the spray pyrolyzed powder into a Pt crucible then thrusting it into a furnace at the desired temperature. Most specimens were held at temperature for 1 hour.

Scanning electron microscopy (SEM)8, and transmission electron microscopy (TEM)h were used to determine grain size and to characterize microstructural development as a function of heat treatment conditions. SEM powder specimens were prepared by bonding the composite flakes to an aluminum SEM specimen holder with graphite dag, then sputter coating with gold. Powder specimens were prepared for observation in the TEM by placing large, thin particles between two carbon coated Cu grids and ion milling for 1 hour in Ar (gun settings: 5 kV, 1 mA). Chemical analysis of powders was performed using energy dispersive spectroscopy (EDS)i in the TEM with a 100 nm diameter probe.

3. Results

Backscattered electron images of specimens containing 10 mol% Al₂O₃ heated to 1100, 1200, 1300, and 1400 °C at 10°C/min. and held for one hour are shown in Fig. 1. At temperatures \leq 1100 °C, the two phase (t-(Zr,Al)O₂ + γ -(Al,Zr)₂O₃) microstructure appears homogeneous by TEM and SEM with a grain size ranging between 40-100 nm (Fig. 1a). At 1200 °C, SEM and TEM images reveal that large (2 to 4 μ m), but thin, plate-like Al₂O₃-rich grains (darker areas in Fig. 1b) containing nanometer ZrO₂ inclusions have formed within a matrix of ZrO₂ grains (lighter areas). As shown in Fig. 1, the plate-like grains are always irregular, and can appear as two or more closely spaced plates (Fig. 1b) that coarsen into single, irregular plates at higher temperatures (Fig. 1c and d). As the plate-like alumina grains are formed, the ZrO₂ microstructure becomes bimodal; ZrO₂ grains immediately surrounding

⁸ JEOL 840-A SEM

h JEOL 2000FX

i Link Analytical

the Al $^{\circ}O_3$ plates are generally larger ($\approx 0.5 \, \mu m$) relative to those elsewhere ($\approx 0.1 \, \mu m$). The Zr O_2 matrix exhibits considerable grain coarsening (0.5 to 3 μm) when heated to 1300 °C/1h, but does not significantly change between 1300 °C/1h and 1400 °C/1h. After heating at 1400 °C/1h, no significant microstructural changes were observed for an additional 1400 °C/24h heat treatment.

The effects of thermal history on the microstructural development is illustrated by comparing Figs. 1 and 2. This comparison shows that the formation of the Al₂O₃-rich phase with a plate-like morphology is retarded by upquenching relative to slow heating. Figure 2 shows backscattered electron images of a specimen containing 10 mol% Al₂O₃ which was upquenched to 1300 °C and held for one and two hours. After one hour at 1300 °C, only a few Al₂O₃ plates are observed; however, a larger number of plates are seen after 2 hours (Fig. 2b). The number density of Al₂O₃ plates is approximately the same for the unquenched specimen held for 2 hr at 1300 °C and the specimen slowly heated to 1300 °C and then cooled, however, the ZrO₂ grain size is smaller for the upquenched sample even though it spent a longer period at 1300 °C (0.1 µm to 0.5 µm for upquenching, Fig. 2a, vs. 0.5 µm to 3.0 µm for 10°C/min to 1300°C/1h, Fig. 1c). Consistent with observations of slowly heated specimens, Fig. 2b shows that the ZrO₂ grains adjacent to the growing Al₂O₃ plates are much larger relative to those in the bulk matrix.

Backscattered electron images of samples containing 40 mol% Al_2O_3 , heat treated at $1200^{\circ}C$, $1300^{\circ}C$, and $1400^{\circ}C$ for one hour, are shown in Figure 3. For heat treatments between $1000^{\circ}C/1h$ and $1200^{\circ}C/1h$, TEM observations show that the two phases present are γ - Al_2O_3 (grain size 5 nm to 15 nm) and t- ZrO_2 (grain size 10 nm to 50 nm). At $1200^{\circ}C/1h$ the grain size of the ZrO_2 matrix appears to slightly increase (20 nm to 100 nm) and a uniformly distributed second phase of γ - Al_2O_3 can be clearly identified with the TEM. In addition, the nucleation and growth of α - Al_2O_3 colonies, each with plate-like morphologies is observed. In contrast to the

composition containing 10 mol% Al₂O₃, where only two or three closely spaced plates are observed at lower temperatures, the composition containing 40 mol% Al_2O_3 forms large colonies of closely spaced plates during the nucleation of α - Al_2O_3 . α-Al₂O₃ regions with an apparent spherulitic morphology (Fig. 3a, lower right hand corner) are occasionally observed, and are believed to correspond to colonies which are viewed normal to the plane of the plates. At 1300 °C/1h, the separation distance between the individual plates within each colony increases. This space becomes occupied well developed ZrO2 grains (= 100 nm). In addition, by 1300 °C/1h, the individual colonies of α -Al₂O₃ plate-like grains have grown large enough to impinge on one another. Larger (0.5 to 1 µm) ZrO2 grains are observed between the colonies. Some coarsening is observed for specimens heated to 1400 °C/1h (Fig 3c), however, the morphology does not change. No significant change in microstructure is observed after a 24 h period at 1400 °C relative to the 1400 °C/1h heat treatment. Figure 3 also illustrates that, at comparable temperatures, the ZrO2 grain size is smaller relative the material containing 10 mol% Al₂O₃ shown in Fig. 1.

Compositions containing 40 mol% Al₂O₃ which were upquenched to 1300 °C and held for different periods had similar microstructures to those which were conventionally heated with the exception that the onset of the plate formation was delayed. Selected area diffraction in the TEM of the upquenched (5 min. at 1300 °C) specimen showed the existence of t-ZrO₂ + γ -Al₂O₃. Specimens which were upquenched to 1300 °C/1h exhibited a uniform microstructure with a grain size of \approx 0.1 μ m to 0.3 μ m (similar to that shown in Fig 1a) with infrequent areas where colonies of plates had begun to form (Fig. 4). The microstructure within the plates is similar to the slowly heated specimen, however, the regions devoid of platelets exhibit a much finer grain size (0.1 vs. 1 mm) relative to the slowly heated specimen.

The microstructure of ZrO_2 -Al $_2O_3$ containing 20 mol% Al $_2O_3$ was examined by SEM at 1100, 1200, and 1300 °C. The temperature at which the Al $_2O_3$ -rich platelets appeared (1200 °C) was identical to 10 and 40 mol% Al $_2O_3$ compositions. Microstructures for the 20 mol% composition appear intermediate relative to those shown and discussed above. Namely, the number of plate-like layers within a given α -Al $_2O_3$ colony and their spacing at 1300 °C is intermediate relative to those shown in Figs. 1c and 3b.

Selected area diffraction patterns (SAD) were used to identify the structure of the plate-like Al₂O₃-rich grains (96 to 99 mol% Al₂O₃ by EDS) in 10 and 40 mol% compositions. For both compositions heat treated at 1300°C/1h, electron diffraction revealed that the plates are α-Al₂O₃ with the 'c' axis perpendicular to the face of the plate. An occasional plate (<1%) had the β-Al₂O₃ structure presumably due to Na contamination either in the precursor or the heating environment. The β -Al₂O₃ plates could easily be distinguished from the α -Al₂O₃ plates by the much larger spacing between lattice fringes when viewed at high resolution. The early stages of α-Al₂O₃ formation were observed in TEM with a 40 mol% Al₂O₃ composition heat treated to 1200°C. Figures 5a and 5b show low and high magnification dark field images of a region of α -Al₂O₃ growing in a t-ZrO₂ + γ -Al₂O₃ matrix. Figure 5c shows a high magnification image of the matrix material. The diffraction pattern in Fig. 5d shows the α -Al₂O₃ pattern ([2 0 $\overline{2}$ 1] zone axis) along with the ring pattern for polycrystalline t-ZrO₂ + γ -Al₂O₃ . In this early stage of growth, the transforming α -Al2O3 colonies exhibit irregular, branching growth, which evolves into the platelike morphology. The ZrO2 grains are uniformly dispersed within the transforming α -Al₂O₃. The matrix material shown in Fig. 5c is an interpenetrating mixture of (t+m)-ZrO₂ (darker) + γ -Al₂O₃ (lighter) without any transformed α -Al₂O₃ regions. (Monoclinic (m) ZrO₂ grains are assumed to transform from t-ZrO₂ during cooling.) Figure 6a shows a TEM micrograph of the cross section of a colony of α-Al₂O₃

(lighter regions) platelets growing into the polycrystalline matrix (heat treated 1300°C/1hr). The brightest region in the center of the photo is a crack. Dark field imaging and electron diffraction has shown that all of the plate-like grains within each colony have the same crystallographic orientation with minor 'tilts' along the length. Figure 6b shows a TEM micrograph of a cross section of two α -Al₂O₃ platelets with similar orientation growing into a matrix of polycrystalline t-ZrO₂ + γ -Al₂O₃ in a 40 mol% Al₂O₃ specimen heat treated to 1300 °C/1hr. An area where the plate thickened in the [0001] direction can clearly be seen in the middle of the brighter plate and nano-meter ZrO₂ grains are observed to be entrapped within the Al₂O₃ single crystal plates. A combination of electron diffraction and dark field imaging verified that the platelets were the same single crystal of α -Al₂O₃ along the entire length. Although an occasional orientation relationship was observed between a ZrO₂ grain and an α -Al₂O₃ plate, the vast majority of ZrO₂ grains adjoining the plates did not show any preferred orientation relation.

4. Discussion

Colonies of lamellar α -Al₂O₃, are observed to form when γ -(Al,Zr)₂O₃ transforms to α -Al₂O₃ within a two phase, t-(Zr,Al)O₂ and γ -(Al,Zr)₂O₃, matrix. The plates are not perfectly planar, contain embedded ZrO₂ inclusions and are separated by ZrO₂ grains. All Al₂O₃ grains within a single colony have the same crystallographic orientation, and thus appear to grow from a single nucleus.

The γ -(Al,Zr)₂O₃ to α -Al₂O₃ transformation temperature observed in the present work is at least 100 °C higher than reported for by others ^{7,8} for pure Al₂O₃ precursors. The higher transformation temperature is presumably due to the need of the ZrO₂ in the metastable γ -(Al,Zr)₂O₃ to partition during the transformation, viz., the equilibrium solubility of ZrO₂ in α -Al₂O₃ is very low.⁹ Similar to the γ to α transformation in pure Al₂O₃ precursors,⁸ the number density of growing nuclei

are very small. Namely, the distance between growing nuclei (or size of the colonies) are = 5 μ m, or = 2 orders of magnitude larger than the grain size of either phase in the metastable, two phase assemblage.

Although Al₂O₃ is known to form plate-like crystals from the vapor state ¹⁰ and plate-like grains with relatively small aspect ratios during high temperature grain growth within dense, polycrystalline Al₂O₃, ¹¹, ¹² the plate-like growth observed in the present work is much different. The major difference is that the growth of the α -Al₂O₃ grains occurs via a transformation (γ -(Al₂Zr)₂O₃ $\rightarrow \alpha$ -Al₂O₃ + t-ZrO2) within a dense, two phase polycrystalline matrix consisting of metastable t- $(Zr,Al)O_2$ and γ - $(Al,Zr)_2O_3$. The formation of the plate-like grains is not observed during the γ to α transformation in pure Al₂O₃ precursors systems.⁸ As shown by Dynys and Halloran, 13 the γ to α transformation in pure Al₂O₃ precursor systems can occur before the nanometer, polycrystalline \u03c4 matrix is fully dense. In this case, the boundary of the growing α-Al₂O₃ grains moves through the porous, nanometer, polycrystalline γ matrix to produce large, 'wormy' α-Al₂O₃ grains, viz., α-Al₂O₃ grains with an embedded, connective porosity. In a similar manner, the growing α -Al₂O₃ grains that form within the t-(Zr,Al)O₂ and γ -(Al,Zr)₂O₃ matrix encompass the ZrO₂ phase. Although entrapment of the ZrO₂ phase suggests that the α-Al₂O₃ grains grow as a moving transformation front without much long range diffusion, the observation that enhanced growth of the ZrO₂ grains surrounding the α-Al₂O₃ plates (Figs. 1b and 2) clearly shows that the plates grow via Al₂O₃ diffusion from the surrounding matrix. That is, lateral redistribution of Al^{3+} in the γ - $(Al,Zr)_2O_3$ phase must occur for the α -Al₂O₃ plates to grow, and for the ZrO₂ grains to coarsen. The α -Al₂O₃ plates grow by a branching mechanism, where the the extent of branching depends on the volume fraction of Al₂O₃, and the spacing between the plates is a function diffusion.

The growth of α -Al₂O₃ as colonies of plate-like grains appears to be caused, in part, by the decrease in molar volume associated with the γ to α transformation within the dense, two phase matrix. That is, large stresses can arise as a growing α -Al₂O₃ (ρ =3.98 g/cc) grain consumes γ -Al₂O₃ grains (ρ =3.65 g/cc) within the surrounding matrix.^{14,15} As detailed elsewhere,¹⁶ when α -Al₂O₃ grains grow with a plate-like morphology (c-axis parallel to the plate axis), the strain energy that arises during the transformation is reduced.

In conclusion, it can be seen that two phase microstructure, with nanometer sized grains can be produced from precursors that crystallize as one phase under kinetically limited conditions, then partition to equilibrium phases at higher temperatures. In the current case, one of the phases develops as colonies of plate-like grains. When the volume fraction of both phases is large, the higher temperature stability of the two phase microstructure can be attributed to the fact that both phases are interpenetrating and the growth of either requires long range diffusion.¹⁷⁻²²

5. Conclusions

It is shown that partitioning of metastable $Zr_{(1-x)}Al_xO_{(2-x/2)}$ containing 10, 20 and 40 mol% Al_2O_3 yields unique nano-composite microstructures. Colonies of plate-like α - Al_2O_3 grains grow during the $\gamma \to \alpha$ phase transformation. The grain size and morphology of the partitioned phases depends on the relevant amounts of each component and the heat treatment conditions. Microstructures that develop from the final partitioned phases exhibit very little grain growth, and remain stable for extended periods at 1400 °C.

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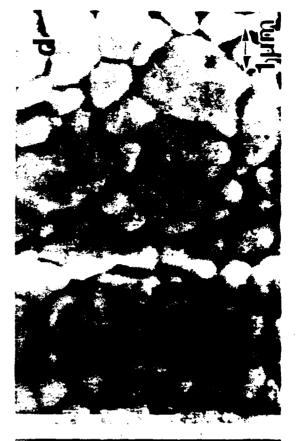
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Figure Captions

- 1.) Backscattered electron images of partitioned $Zr_{(1-x)}Al_xO_{(2-x/2)}$ containing the equivalent of 10 mol% Al_2O_3 heat treated at (a) 1100 °C/1h, (b) 1200 °C/1h, (c) 1300 °C/1h and (d) 1400 °C/1h. Microstructure at 1100 °C/1h is two phase, t- $ZrO_2 + \gamma$ - Al_2O_3 ; α - Al_2O_3 nucleates at 1200 °C as stacked plates with embedded, nano-meter ZrO_2 crystallites.
- 2.) Backscattered electron images of partitioned Zr_(1-x)Al_xO_(2-x/2) containing the equivalent of 10 mol% Al₂O₃ upquenched to (a) 1300 °C/1h, (b) 1300 °C/2h.
- 3.) Backscattered electron images of partitioned Zr_(1-x)Al_xO_(2-x/2) containing the equivalent of 40 mol% Al₂O₃ heat treated at (a) 1200 °C/1h, (b) 1300 °C/1h and

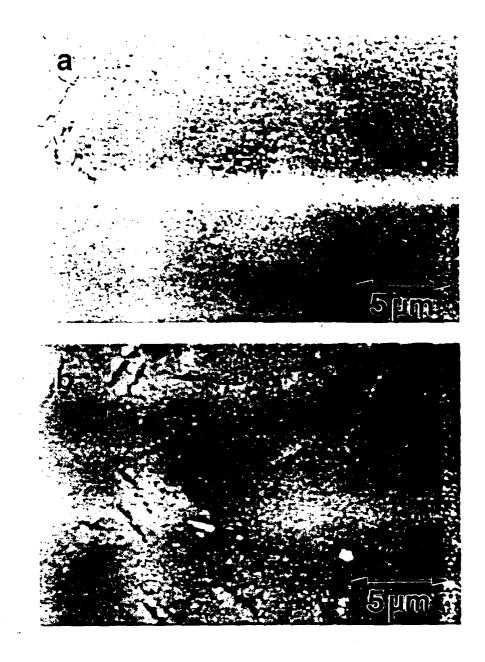
- (c) 1400 °C/1h. At 1200 °C Al₂O₃-rich regions grow as stacked plates within t- $ZrO_2 + \gamma Al_2O_3$ two phase matrix.
- 4.) Backscattered electron image of partitioned Zr_(1-x)Al_xO_(2-x/2) containing the equivalent of 40 mol% Al₂O₃ upquenched to 1300 °C/1h.
- 5.) (a) Low and (b) high magnification dark field images of α -Al₂O₃ single crystalline regions, (c) matrix material (t+m)-ZrO₂ + γ -Al₂O₃, and (d) diffraction pattern of the polycrystalline matrix (t+m)-ZrO₂ + γ -Al₂O₃, and the single crystal α -Al₂O₃ in 40 mol% Al₂O₃ heat treated (10 °C/min) to 1200°C/1h.
- 6.) TEM micrograph of (a) a stack of α-Al₂O₃ platelets and (b) the tip of two α-Al₂O₃ platelets growing into a polycrystalline (t+m)-ZrO₂ + γ-Al₂O₃ matrix in a partitioned Zr_(1-x)Al_xO_(2-x/2) containing the equivalent of 40 mol% Al₂O₃ heat treated (10 °C/min) to 1300 °C/1hr. Platelets within a stack have the same crystallographic orientation.

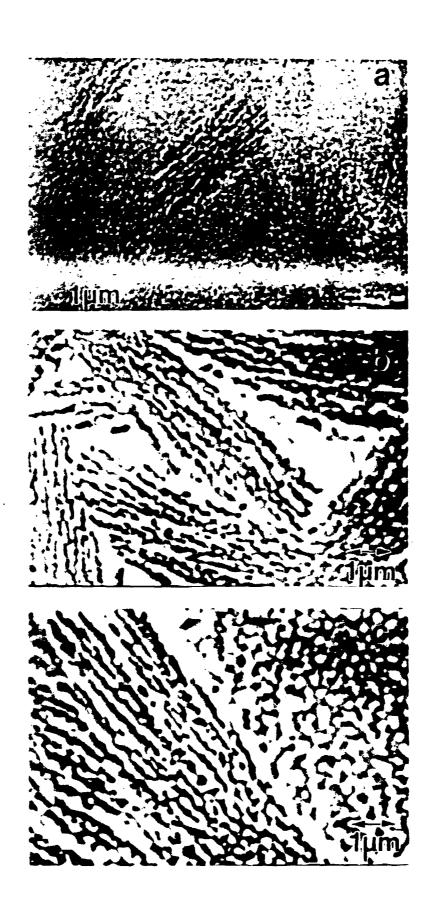






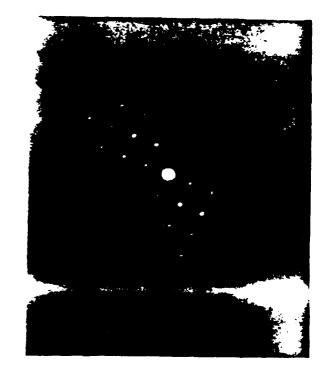


















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Figure 6

High Temperature Stability of Binary Microstructures Derived From Liquid Precursors

Contract AFOSR-91-0125

Technical Report No.11

²⁷Al NMR of Zr_(1-x)Al_xO_(2-x/2) Solid Solutions Synthesized with Solution Precursors

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Abstract

The local environment of the aluminum atoms in a series of metastable $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions (0.08 \le x \le 0.57), prepared by diffusion-limited crystallization of amorphous precursors, has been determined by ^{27}Al magic-angle spinning (MAS) NMR. Results show the existence of aluminum in 4-, 5-, and 6-fold coordination in both the amorphous and crystalline states. While the relative amounts of each type of coordination show no compositional dependence in the amorphous state, the results for the crystalline materials show a systematic decrease in the average Al coordination number with increasing Al content. Comparisons of MAS NMR results between pure Al_2O_3 precursors and $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions processed under the same conditions show a profound effect of zirconia on the coordination environment of the Al atom. Both a random distribution model and a model which assumes small scale clustering of Al ions are considered to explain the trends in the type of Al coordination as a function of composition.

1.0 Introduction

As shown in previous papers 1,2 a single phase solid solution with stoichiometry $Zr_{(1-x)}Al_xO_{(2-x/2)}$ crystallizes from pyrolyzed amorphous precursor samples over the range $0.08 \le x \le 0.58$ (4 to 40 mol% Al_2O_3). Combined evidence from TEM, XRD and Raman spectroscopy shows that the $Zr_{(1-x)}Al_xO_{(2-x/2)}$ system is single phase with the t-ZrO₂ structure. This large extension of the solubility range is unusual, since the equilibrium phase diagram predicts that even at high temperatures the maximum solubility of Al_2O_3 in t-ZrO₂ is < 2 mol%, which corresponds to a cation site substitution of $x \approx 0.04$.

In order to better understand the structural organization of these extended solid solutions it is helpful to examine the structure of each end member. t-ZrO₂ (S.G. P4₂/nmc) is a distorted derivative of the fluorite structure (S.G. Fm3m) shown in Figure 1. The zirconium ions occupy the corners and face centered unit cell positions and the oxygens occupy the tetrahedral sites. Each Zr is coordinated by eight oxygen ions, and each oxygen is coordinated by four Zr ions. Likewise, the oxygen ions have six oxygen next-nearest neighbors, and the Zr ions have 12 Zr next-nearest neighbors. As in the case with other trivalent and divalent ions (Y3+, Ga3+, Ca2+, Mg2+) which form solid solutions with ZrO2, it is expected that Al3+ ions will substitute for Zr4+. In order to maintain local charge balance, an oxygen vacancy must be created for every two trivalent ions substituted for Zr4+. The yttria structure, which results from replacing all the Zr⁴⁺ by Y³⁺ in ZrO₂, is body centered cubic (D53), and may be visualized as a defect fluorite derivative where 25% of the oxygen sites are vacant, but all the cations remain approximately in the same f.c.c. array. The difference in stoichiometry leads to displacements of the true ionic positions away from those occupied in the fluorite structure, and hence to a change in cationoxygen coordination, from cubic in ZrO2 to octahedral in Y2O3. In the case where yttria partially substitutes for Zr in the fluorite structure, Y3+ ions may be coordinated by 6 or 7 oxygens, depending on the number of closest Y3+ neighbors.

Aluminum has never been observed in 7-fold coordination with oxygen. In the crystal structures of the common polymorphs of Al₂O₃, the Al

ions are in tetrahedral and octahedral sites. The oxygen ions are in face centered cubic (γ , δ , and Θ), and hexagonal close packed (α) arrangements, and within each of these groups, the ordering of cations gives rise to the different polymorphs. The γ -Al₂O₃ structure, which is the first phase to partition from $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions, possesses a spinel-like structure. The Al ions are randomly distributed such that 10% of the tetrahedral sites and 46.7% of the octahedral sites are filled.³

The local environment of the Al ion (i.e. the Al-O coordination) can be determined with ²⁷Al magic angle spinning nuclear magnetic resonance (MAS NMR). MAS NMR studies on Al₂O₃ formed from various precursors have shown the existence of Al-O in 5-fold, as well as 4- and 6-fold coordinations. The relative amounts of each type of coordination varied depending on the starting materials, and as a function of heat treatment temperature.^{4,5} 5-coordinate Al species are also known to exist in several minerals and synthesized compounds such as andalusite, grandidierite, yoderite, augelite, senegalite, AlPO₄-12, and AlPO₄-21, and several organic complexes. ⁶

2.0 Experimental

2.1 Sample Preparation and Characterization.

ZrO₂-Al₂O₃ mixtures containing the equivalent of 0, 4, 7, 10, 15, 29, 33, 40, and 50 mol% Al₂O₃ (x = 0, 0.08-0.67) after pyrolysis were fabricated from aqueous solutions of zirconium acetate and aluminum nitrate. As detailed in an earlier paper,¹ the solutions were spray pyrolyzed in order to maintain intimate mixing and avoid selective crystallization of aluminum nitrate. The precursor compositions were all heated at a rate of 15°C/minute to 400°C and held for one hour to ensure that decomposition was complete. Previous work ¹ has shown that crystallization occurs at temperatures > 400°C, thus the 400°C samples were amorphous. After the 400°C treatment, a portion of the different samples were 'upquenched' to a temperature just above the crystallization temperature, which systematically increases with Al₂O₃ content.¹ The 'upquench' procedure consisted of placing an amorphous powder into a platinum crucible, inserting it into a furnace, pre-heated to the desired temperature, holding 5 minutes, then removing the sample into

ambient temperature. The phase selection as a function of composition and upquench temperature for the crystalline samples is reported in reference 1.

2.2 NMR Studies

²⁷Al MAS NMR was performed at 78.3 and 130.3 MHz on General Electric GN-300 (7.05 T) and GN-500 (11.7 T) spectrometers equipped with probes from Doty Scientific. The following experimental parameters were used: pulse length = 1μs (45° solid flip angle), recycle delays 1 s, spinning speed = 8-10 kHz. Spin counting studies were carried out with weighed samples and γ -Al₂O₃ as the quantitation standard. The results indicate that both in the amorphous and the crystalline samples the fraction of Al detected amounts to ca. 75-90% of the fraction of the Al atoms detected in γ - Al₂O₃ with no evident compositional dependence. Standard spectrometer software was used to eliminate the ²⁷Al probe background signal. Resonance shifts were obtained at 130.3 MHz relative to a 1M aqueous solution of aluminum nitrate.

3.0 Results

NMR spectra collected at 130.3 MHz for samples containing the equivalent of 4 and 40 mol% Al₂O₃ (x = 0.08 and 0.57) in the amorphous and crystalline states are summarized in Figure 2; for the crystalline samples, the whole compositional series is displayed in Figure 3. The spectra are characterized by three resonance maxima near 60, 30 and 0 ppm, which are assigned to aluminum sites in four-, five- and six-fold coordination with oxygen. These resonances are flanked by broad shoulders which comprise spinning sidebands and possibly lineshape components not narrowed under the present experimental conditions. The resonance positions measured for the 4-, 5-, and 6-coordinated aluminum species are not equal to the chemical shifts, because the field-dependent NMR studies show a contribution, $\delta^{(2)}$, due to second-order quadrupolar effects:

$$\delta_{\rm exp} = \delta_{\rm iso} + \delta^{(2)} \tag{1}$$

Second-order quadrupolar interactions also lead to substantial line-broadening effects in the MAS-NMR spectra of quadrupolar nuclei such as ²⁷Al, and decrease with increasing field strength. Comparison of spectra collected at 78.3 and 130.3 MHz reveals substantially improved resolution at the higher field strength, indicating the dominance of second-order quadrupolar broadening effects on the MAS-NMR lineshapes. Due to this situation, the exact lineshapes for the individual Al(4), Al(5), and Al(6) sites are expected to deviate from the regular Gaussians usually observed in MAS-NMR. Therefore, it is impossible to deconvolute the overall MAS NMR spectra in terms of quantitatively reliable site populations. However, assuming that the MAS NMR lineshape parameters for Al(4), Al(5), and Al(6) do not change over the range of compositions studied, the compositional trends in these site populations (relative percentages) can be visualized as shown in Figure 4 using peak height measurements, P(x).

$$P(x) = 100 \cdot I_x / (I_4 + I_5 + I_6)$$
 (x = 4, 5, 6), (2)

where I₄, I₅, and I₆ are the peak heights of the MAS NMR lineshape components assigned to the respective aluminum sites. While the parameters P(x) are not equal to these site populations, it is our working assumption that any compositional change in P(x) is due to a change in these site populations. Because the peak overlap is more pronounced lower field strengths, the relative percentages of the aluminum sites as determined by this procedure from the 78.3 MHz spectra are somewhat different from those determined at 130.3 MHz. For this reason, the analysis of the 130.3 MHz is preferred, and the results shown in Figures 5 and 6 are based on these high-field data. Regardless of the assumption, is worth noting, that each data set produces the same compositional trend in the aluminum population distribution.

As shown in Figure 5, there is little evidence that in the amorphous samples the relative percentages of each type of Al coordination vary substantially over the range of 7-40 mol% Al₂O₃. Mixtures containing 4 mol% Al₂O₃ appear to have more 6-coordinated Al, and less 5- and 4-coordinated Al than is observed at other compositions. Samples containing 50 mol% Al₂O₃ exhibit anomalously large amounts of 5- and 4-coordinated Al, and low amounts of 6-coordinated Al. For 100% Al₂O₃ in the amorphous

state, the fraction of 4-coordinated Al is consistent with that in most of the samples, however, the relative percentage of 5-coordinated Al sites is significantly lower than that found in most of the $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions. This difference clearly illustrates the effect of zirconia on the aluminum speciations in the amorphous state.

Figure 6 shows the changes in P(x) for 4-, 5-, and 6-coordinated Al as a function of Al content for crystalline $Zr_{(1-x)}Al_xO_{(2-x/2)}$ upquenched to a temperature just above the crystallization temperature. It can be seen that for compositions with small Al contents, the Al ion is primarily in 5- and 6-fold coordination. With increasing Al content, the relative percentage of 4-fold coordinated Al sites increases, whereas the 5- and 6-fold coordinated Al sites decrease. Figure 6 reveals a systematic compositional trend in the population distribution of the various aluminum sites over the range $4 \le \text{mol}\%$ Al₂O₃ ≤ 40 . At 50 mol% Al₂O₃ an anomalously large amount of 6-coordinated Al is observed. As shown previously¹, the 50 mol% Al₂O₃ composition is known to partition during crystallization, resulting in the formation of γ -Al₂O₃. This is reflected in the relatively large fractions of 4- and 6-coordinated Al. For a sample which is known to be γ -Al₂O₃, P₄ and P₆ are measured as 78% and 22% respectively, as can be seen on Figure 6 for the 100% Al₂O₃ composition.

It is important to note that the representation of the data in Figures 5 and 6 does not reflect the absolute quantities of each type of Al-O coordination. The absolute amounts of each component increase systematically with increasing Al₂O₃ content in the solid solutions as expected. Overall, the quantity of each component increases as a function of Al content as measured by the peak intensities for amorphous and crystalline samples.

As shown previously¹, the crystallization temperature of the amorphous, pyrolyzed precursor increases with Al content. Therefore, the compositions represented in Figures 3 and 6 had to be upquenched to successively higher temperatures in order to promote crystallization. In order to ensure that the trends in Al coordination are indeed an effect of composition and not of crystallization temperature, spray pyrolyzed samples of pure Al-nitrate precursor were fabricated and upquenched to temperatures close to those for the samples shown in Figure 6. The trend in the relative percentages of 4-, 5-, and 6-coordinated Al sites as a function of increasing upquench temperature for pure Al₂O₃ is shown in Figure 7 (corresponding

Al₂O₃ contents for Zr(Al)O₂ upquenched to the same temperature are shown in parenthesis). The data shown in Figure 7 were collected at 78.3 MHz, however, the trend is expected to be the same at 130.3 MHz. The relative percentage of 4-coordinated Al is constant over the temperature range studied, while the fraction of 6-coordinated Al increases slightly at the expense of 5-coordinated Al atoms, as the crystallization temperature increases. Overall, the trend in these samples is comparable to that in the amorphous mixed Zr(Al)O₂ samples, but decidedly different from that seen in the crystallized Zr(Al)O₂ materials (Fig. 6). Thus, it is clear that the dramatic changes in the aluminum coordination distribution in the crystallized Zr(Al)O₂ materials is not simply an effect of annealing temperature, but specifically reflects the interactions between the zirconia and alumina constituents in the crystalline state.

Figure 8 shows the compositional dependence of the resonance shift, measured at 130.3.MHz, associated with the 6-coordinated Al sites. There is no apparent dependence of the peak shift on the Al₂O₃ content for the glassy samples. However, the crystalline materials exhibit a monotonic downfield shift trend as a function of increasing Al₂O₃ content from 1.0 ppm to 9.1 ppm, the latter being the value observed for 6-coordinated Al in pure γ -Al₂O₃. This indicates that the environment of 6-fold Al in $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions varies significantly from that in γ -Al₂O₃ but approaches it with increasing Al content as expected.

Figure 9 summarizes the results of the spin counting studies. It can be seen that in all $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions, approximately 75-90% of the Al detected in γ -Al₂O₃ is detected, regardless of exact composition. This suggests that if 7-fold Al is the portion which is undetected, the amount of 7-coordinated Al would be the same over the range of compositions of $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions, a rather unlikely scenario. An alternative explanation of the signal loss is the larger line width of the peaks associated with the Al(5) sites, compared to those of the Al(4) and Al(6) sites in γ -Al₂O₃. This may result in incomplete detection of the Al(5) species in the solid solutions where Al(5) is highly abundant. The broadening of the Al(5) line presumably arises from stronger quadrupolar interactions as compared to the other sites.

4.0 Discussion

It is obvious that the crystallization of $Zr_{(1-x)}Al_xO_{(2-x/2)}$ from the amorphous precursor, as well as the amount of Al in solid solution, has a profound effect on the Al-O coordination. In order to explain observed trends in Al site populations, two scenarios will be considered: 1) The oxygen vacancies generated by the Al substitution are randomly distributed in the zirconia lattice, and 2) The substitution generates clusters of Al atoms, with Al next nearest neighbors, that are larger than those predicted by random distributions, and the Al-O coordinations at the interface between the Al clusters and the matrix are different than those in the center of the cluster.

4.1 Random Distributions

The case where the oxygen vacancies are randomly distributed represents one extreme scenario. It assumes that the amorphous pyrolyzed materials are intimately mixed, and that there is no redistribution of solute upon crystallization of $Zr_{(1-x)}Al_xO_{(2-x/2)}$. Since an oxygen vacancy must be created for every two Al3+ ions substituting for Zr, a random distribution of vacancies results in a non-random distribution of Al atoms, as local charge constraints mandate that each oxygen vacancy is next to two Al sites. For such a pseudo-random distribution, the average Al-O coordination number should decrease from 7 to 6 with increasing Al content, reflecting the increasing number nal of aluminum atoms with at least one Al next nearest neighbor. The dependence of the average Al coordination number as a function of nA1 is shown in Figure 10. As in the case of Y3+-substituted zirconia, even with complete substitution of Al for Zr in the fluorite structure, the minimum average Al-O coordination number should be 6. The trends determined experimentally for the $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions show an overall decrease in the average coordination number as a function of Al content similar to the trend expected for random distributions. However, the presence of 4-, $(x \ge 0.13)$ and 5-fold Al sites in relatively large amounts and the apparent absence of 7-coordinate Al environments can not be explained by this model.

Due to the distorted local symmetry of a 7-fold coordinated Al-O environment, the question arises as to whether the corresponding ²⁷Al NMR

signal might be broadened beyond detection due to strong second-order quadrupolar effects. The fact that approximately 75-90% of the total Al signal observed for pure γ -alumina is detected for all compositions (0.08 \leq x \geq 0.57) suggests that if 7-coordinated Al is present, it does not exist in significantly larger quantities for the lower concentrations of Al, as would be expected from the random distribution model. However, the current experiments do not explicitly rule out the existence of 7-fold coordinated Al atoms. It is a reasonable conjecture that relaxations or distortions of the fluorite structure could occur in the presence of Al-vacancy-Al groups. The Al³+ near a vacancy may suffer small local distortions of its oxygen environment causing some Al-O distances to become larger than others. This could effectively reduce the Al coordination number, and thus may make a 7-fold environment appear like a 5- or 6-fold Al site in 27 Al MAS NMR.

Another reason for the lower Al coordination numbers may be grain boundary or surface effects. As shown previously by TEM, the initial particle size of upquenched $Zr_{(1-x)}Al_xO_{(2-x/2)}$ is 3-5 nm. For these very small grain sizes, the grain boundary area becomes significantly large. The surface area per unit volume can be calculated using the simple equation:⁷

$$S_{V} = \frac{2}{C} \tag{3}$$

where Sy is surface area per unit volume (1/length) and G is the grain size (length). If we assume that the grain boundary is one unit cell thick (= 5 Å), then for an average grain size of 3 nm, 32 vol% of the material resides on the grain boundaries. Likewise for an average grain size of 5 nm, 20 vol% of the material resides on the grain boundaries. Cations which reside on the surface or grain boundary, are expected to have a lower coordination than those in the bulk. Therefore, assuming a completely random distribution of vacancies, aluminum atoms expected to be in 7- and 6-coordination may actually occur in 6- and 5-fold coordination, respectively. Since 8-fold coordination is energetically favorable for Zr, Al ions may preferentially reside on the surface of these domains. Regardless of these assumptions, it is clear that the random model cannot explain the experimental presence of Al(4) species.

TEM and DTA analysis shows that the crystallization of $Zr_{(1-x)}Al_xO_{(2-x/2)}$ solid solutions from the amorphous phase occurs slowly over a temperature range of ≈ 100 °C. It is possible that in the upquenched samples prepared for NMR experiments, small regions may remain amorphous after the heat treatment. These amorphous regions are expected to have Al-O coordination distributions similar to the amorphous $Zr(Al)O_2$ samples shown in Figure 4 ($P_4 \approx 0.2$, $P_5 \approx 0.42$, and $P_6 \approx 0.38$). Since four coordinated Al cannot be explained by the random distribution model as discussed above, it might be associated exclusively with the residual amorphous phase. Al in 6- and 5-fold coordination may result from either the crystalline or amorphous phases. If the volume fraction of the amorphous phase increases with increasing Al content, then a trend in average coordination number similar to that seen in the experimental data could be envisioned. Based on this interpretation the solubility of alumina in zirconia might be significantly lower than previously imagined.

4.2 Clustering of Second Phase

A second model can be considered where the Al ions form Al-O-Al bonded clusters larger than those predicted by random distributions. Since percolating clusters can be physically described as irregular branching strings, the Al-rich clusters will be modeled here using a rod-like geometry, with a large aspect ratio. It is expected that the Al ions at the surface of the rod will be affected by the neighboring Zr4+ ions, and will have higher Al-O coordination numbers than in the center of the rod where the structure has relaxed to one corresponding to amorphous Al₂O₃. The relative amounts of 4-, 5-, and 6-coordinated Al atoms in the center are estimated from experimental values for pure Al₂O₃ upquenched to 600 °C \leq T \leq 800 °C. The Al-atoms on the surface of the rod (with a thickness of 1/2 a unit cell) are assumed to be in only 5- and 6-fold coordination. At small cluster sizes where the surface to volume ratio (S/V) is large, Al will be primarily in 5- and 6-fold coordination, but as the cluster size increases the relative amount of 4-fold Al is expected to increase. Figure 11 illustrates the expected trend in the Al coordination distribution for an initial aspect ratio (1/r) = 100/1 as a function of increasing cluster size. The trend is similar to that seen in Figure 6 for the experimental results for $0.08 \le x \le 0.57$.

MAS NMR experimental observations which show a change in the relative percentages of each type of coordination upon crystallization, as well as the observed trend for the Al(6) resonance shifts in the crystalline $Zr_{(1)}$ x)AlxO(2-x/2) solid solutions, preclude the existence of large areas (on the order the grain size) of amorphous material. Similarly, TEM observations 1 of the initial crystalline microstructure did not reveal any recognizable amorphous regions. The uncertainty in the ability to detect 7-coordinated Al atoms or the manner in which the latter might manifest themselves in MAS NMR, makes it difficult to differentiate reliably between both models. It is therefore not possible to determine the precise solubility limit of the fluorite structure for aluminum substituents. Evidence suggests that the samples examined consist of random solid solutions at the lowest mole fractions of Al (<10 mol%). This conclusion is based on the absence of Al(4) sites in such samples. With increasing Al content larger Al-rich clusters form, whose size is probably larger than the cluster size predicted by random distributions. Most likely these clusters exist as disordered regions within the individual crystallites or on their surfaces.

5.0 Conclusions

It has been shown by 27 Al MAS NMR that in crystalline $Zr_{(1-x)}Al_xO_{(2-x)}$ x/2) solid solutions prepared from amorphous precursors, the Al ions are in 4-, 5-, and 6-fold coordination with oxygen. The relative amount of Al(4) sites increases, whereas the relative amount of Al(5) and Al(6) decreases systematically with increasing Al content in the crystalline materials. This trend may in part reflect the overall decrease of average Al coordination number expected for a random distribution of vacancies. As the number of Al next nearest neighbors increases with increasing Al content, the average coordination number is expected to decrease. On the other hand, the experimental data, specifically the occurrence of 4-coordinated Al sites, can also be explained by the formation of Al₂O₃ clusters larger than those predicted by random distributions. In the cluster model, the coordination of the atoms on the surface of the clusters is expected to be influenced by the neighboring Zr atoms, while the atoms in the center of the clusters have coordination distributions similar to amorphous alumina. Seven-fold coordinated Al was not identified in this study. While such a species may go

undetected due to strong second order quadrupolar broadening effects, the spin counting studies carried out here indicate that the fraction of undetected signal is independent of composition, contrary to what is expected for the concentration of Al(7) in a random distribution model. It is, however, quite possible that the local structure around such a 7-coordinate Al atom relaxes, resulting effectively in lower coordination numbers.

6.0 Acknowledgements

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7.0 References

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Figure Captions

- Figure 1: Schematic representation of the fluorite structure with the anions defining the unit cell.
- Figure 2: 130.3 MHz 27 Al MAS-NMR spectra for $Zr_{1-x}Al_xO(2-x/2)$ solid solutions containing 4 and 40 mol% Al_2O_3 (x = 0.08, bottom, and 0.57, top).
- Figure 3: 130.3 MHz ²⁷Al MAS-NMR spectra of crystalline solid solution samples in the zirconia-alumina system. The compositions (mole% Al₂O₃) are indicated.
- Figure 4: Schematic of peak height measurement procedure from the ²⁷Al MAS-NMR spectra.
- Figure 5: Relative percentages of 4-, 5-, and 6-fold coordinated Al as a function of Al content in amorphous Zr(Al)O₂ heat treated at 400 °C/1hr, measured from ²⁷Al MAS-NMR spectra at 130.3 MHz.
- Figure 6: Relative percentages of 4-, 5-, and 6-fold coordinated Al as a function of Al content in crystalline $Zr_{(1-x)}Al_xO_{(2-x/2)}$, measured from ²⁷Al MAS-NMR spectra at 130.3 MHz.
- Figure 7: Relative percentages of 4-, 5-, and 6-fold coordinated Al as a function of upquench temperature for Al₂O₃ formed from spray pyrolyzed aluminum nitrate, measured from ²⁷Al MAS-NMR spectra at 78.3 MHz.
- Figure 8: Resonance shift ±0.5 ppm (vs. 1M aq. Al(NO₃)₃ solution) of the 6-fold coordinated Al peak as a function of equivalent Al₂O₃ content in amorphous and crystalline mixtures, measured from ²⁷Al MAS-NMR spectra at 130.3 MHz.

- Figure 9: 27 Al MAS NMR signal intensity at 130.3 MHz relative to that measured in crystalline γ -Al₂O₃ as a function of equivalent Al₂O₃ content in amorphous and crystalline mixtures. The error in this measurement is estimated at $\pm 5\%$.
- Figure 10: Expected average Al coordination number in the fluorite structure as a function of n_{Al}, the number of Al atoms contained in alumina clusters with Al next nearest neighbors.
- Figure 11: Predicted relative percentages of 4-, 5-, and 6-fold coordinated Al as a function of increasing cluster volume. Clusters have a rod-like geometry where the center of the cluster contains Al in 4-, 5-, and 6-fold coordination in the same quantities as amorphous Al₂O₃, and the surface contains only 5- and 6- coordinated Al.

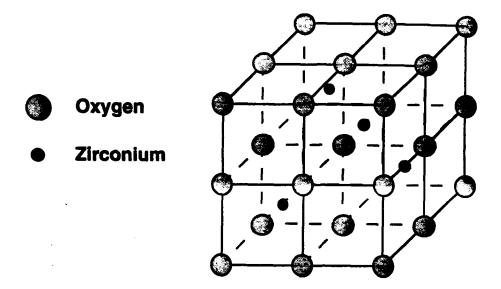
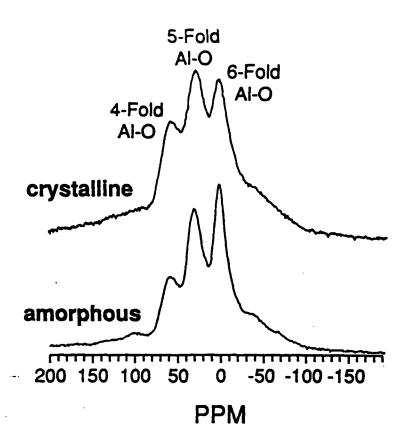


Figure 1



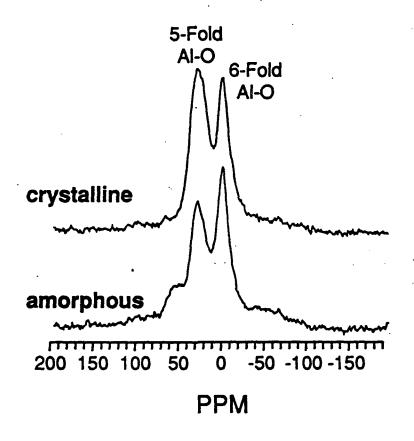


Figure 2

Figure 3

o PPM

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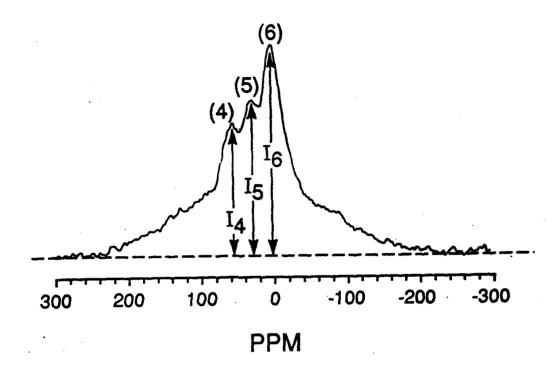


Figure 4

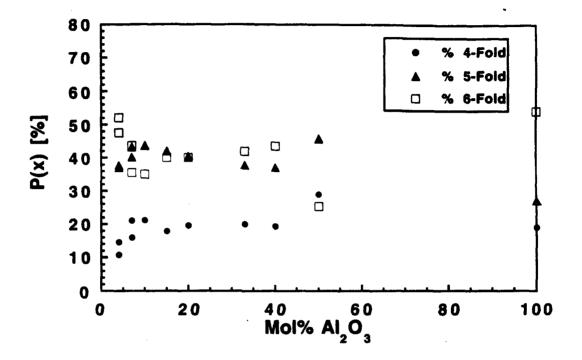


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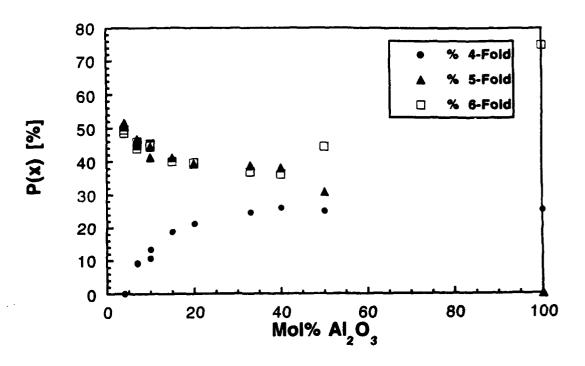


Figure 6

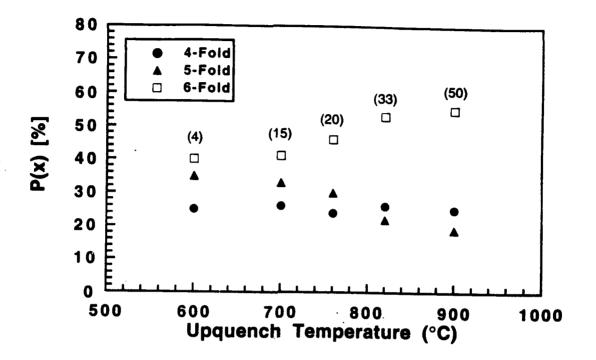
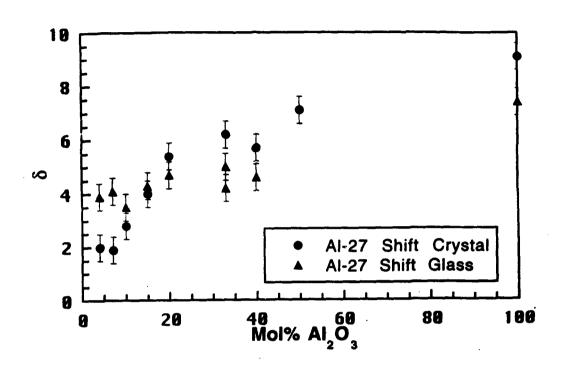
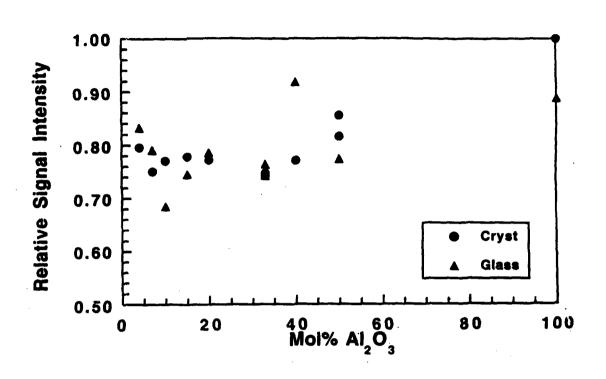


Figure 7



· Figure 8



· Figure 9

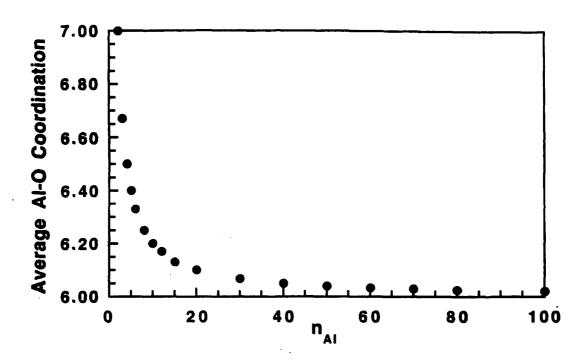


Figure 10

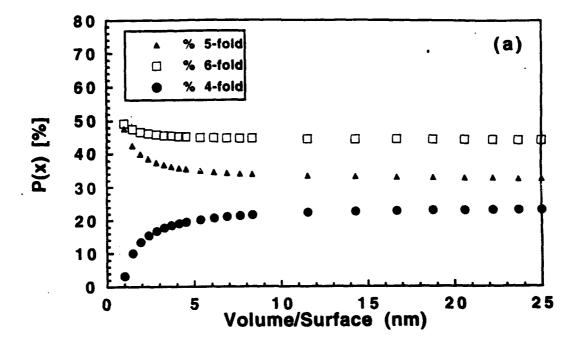


Figure 11

High Temperature Stability of Binary Microstructures Derived From Liquid Precursors

Contract AFOSR-91-0125

Technical Report No. 12

Epitaxial Growth of PbTiO₃ Thin Films on {100} SrTiO₃ from Solution Precursors

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Abstract

A mixed alkoxide liquid precursor was used to form epitaxial PbTiO3 thin films by spin-coating on cubic (001) SrTiO3 substrates. The films were heat-treated at temperatures between 380°C/1h and 800°C/1h. X-ray diffraction, atomic force microscopy, scanning and transmission electron microscopy were used to characterize the microstructure of the films and to evaluate the epitaxial phenomena. At ~400°C/1h, a polycrystalline, metastable Pb-Ti-fluorite crystallizes from the pyrolyzed amorphous precursor. At slightly higher temperatures (~420°C/1h), the thermodynamically stable phase with the perovskite structure epitaxially nucleates at the film/substrate interface. A small number of epitaxial grains grow through the film toward the surface and consume the nano-crystalline fluorite grains. Coarsening of the perovskite grains leads to a reduction in mosaic spread during further heating. Pores, that concurrently coarsen with grain growth, produce a pitted surface as they disappear from within the film. At 800°C/1h a dense epitaxial PbTiO₃ film with a smooth surface is observed. Parameters governing the formation of a- and c-domains are discussed as well as the small tilts of the domain axes away from the substrate normal.

1. Introduction

Single crystal ferroelectric thin films are preferred to polycrystalline films for a range of optical and electronic applications.¹ Kingon², for example, has shown that the single crystal films have improved aging and fatigue behavior in non-volatile memory applications. The pyroelectric properties of PbTiO₃ are optimal along the polar direction, thus single crystal films are preferred for pyroelectric devices.³ Also, devices that use optical transmission require films that do not scatter light. A number of techniques have been employed to grow either oriented or epitaxial thin films of ferroelectric lead titanate, lead titanate zirconate (PZT) and lanthanum modified PZT (PLZT) on single crystal substrates including MgO,^{3-5,13} SrTiO₃,^{6,12} MgAl₂O₄/Si,¹¹ YBa₂Cu₃O₇/LaAlO₃,⁹ (La,Sr)CoO₃/SrTiO₃,⁸ (La,Sr)CoO₃/MgO,⁸ (La,Sr)CoO₃/Zr(Y)O₂/Si,¹⁰ Pt/MgO,^{3,5} as well as Pt/Ti/SiO₂/Si.^{5,7} Deposition methods include radio frequency sputtering,³⁻⁷ pulsed laser deposition,⁸⁻¹⁰ and chemical vapor deposition.¹¹⁻¹³

A small number of groups have been processing thin films by solution chemistry routes. In these methods, a precursor solution 14,15 containing metalorganic molecules in either an aqueous or organic solvent is used to form a solid precursor film on a substrate by either spin-coating 16 or dip-coating. 17 During coating the solvent evaporates to produce a solid, amorphous precursor film. The precursor film decomposes (pyrolyzes) and crystallizes during heating at low temperature to from a partially dense, polycrystalline thin film of the desired inorganic composition.

The mechanisms leading to epitaxy in precursor derived films are different from phenomena associated with vapor phase epitaxy. Several of these mechanisms have been identified. Miller et al. 20 have shown that when the film and substrate have the same crystal structure, and the lattice mismatch is small, oriented nano-crystallites in contact with the substrate eventually grow along the

film/substrate interface and then through the film to consume all randomly oriented grains. This process was called epitaxial grain growth. The same mechanism is likely for heteroepitaxy of tetragonal Zr(Y)O₂ compositions on (001) cubic zirconia substrates.²¹ Even when the film and substrate have unrelated structures, epitaxial films are possible but they are formed by an intermediate step that causes the polycrystalline film to break into isolated epitaxial grains.²² These isolated grains can then be used as seeds to form a continuous film after the substrate is recoated and reheated. Vaidya et al.²³ have shown that the oxide precursor may react with the substrate and form an epitaxial thin film. Epitaxial films may also form at higher temperatures through a liquid phase process.²⁴

A variety of different precursor chemistries and substrates have been used to produce single crystal ferroelectric films. Sapphire substrates were used for Nb-doped PZT thin films.²⁵ The growth of highly oriented PZT 53/47 (PbZr_{0.53}Ti_{0.47}O₃) films was reported by Schwarz et al.²⁶ on (001) SrTiO₃. Hirano et al.²⁷ studied the influence of a wet oxygen atmosphere on the pyrolysis and orientation of PZT 53/47 films formed on (001) SrTiO₃, (001) MgO and platinized silicon. Tuttle et al.²⁸ grew highly textured PZT 40/60 on (001) Pt/MgO and on (001) MgO. Epitaxial PLZT films on SrTiO₃ were reported by Yoon et al.²⁹

The goal of the current study was to identify the epitaxy mechanism for the PbTiO₃ (PTO) film formation on (001) SrTiO₃ (STO) single crystal substrates. STO was chosen as the substrate because its lattice parameters at the growth temperature of PbTiO₃ (above the Curie temperature, $T_c = 490$ °C) are similar to the parameters of cubic paraelectric (PE) PTO. At 800 °C/1h for example, apto is 0.3975 nm and asto equals 0.3938 nm. Thus the unrelaxed, linear in-plane strain is about 1%, and much smaller than for other oxide substrates such as MgO or MgAl₂O₄. Also, the thermal expansion mismatch between STO and PTO above T_c is relatively small ($\alpha_{PTO} = 12.6 \times 10^{-6}$ /K (T > 490 °C) and $\alpha_{STO} = \sim 11 \times 10^{-6}$ /K (20 °C - 1000 °C)). During cooling

through T_c , PbTiO₃ transforms to a tetragonal ferroelectric and below T_c the tetragonal a-axis of PTO (apto = 0.3904 nm, cpto = 0.4152 nm, at room temperature) becomes closely matched to the cubic STO lattice parameter (a_{STO} = 0.3905 nm).

Most studies of PbTiO₃, PZT or PLZT perovskite films report a metastable intermediate phase at lower processing temperatures. This phase is usually described as 'pyrochlore'.^{3,5,30-35,44} The pyrochlore phase is generally seen as a disadvantage because it can be retained after processing at high temperatures and it is known to deteriorate the ferroelectric properties of the films.³⁴ In our study we have found that the crystallization of the Pb-Ti-fluorite may be advandageous for low temperature epitaxy of PbTiO₃. Formation of the intermediate fluorite reduces the free energy in the PbO-TiO₂ system and thus promotes selective heterogeneous nucleation of epitaxial perovskite at the film/substrate interface. However, because the fluorite-to-perovskite transformation takes place rapidly at low temperature, unwanted porosity, present in the low density fluorite film, becomes entrapped within the epitaxial film. This aspect of the fluorite to perovskite transformation is a disadvantage since higher processing temperatures of ~0.69·T_{melting} of PbTiO₃ are needed to eliminate the entrapped porosity and to form a smooth and epitaxial film.

2. Experimental

Lead Titanate thin films were prepared by spin coating (Headway Research Inc., Garland, TX) SrTiO₃ (Coating & Crystal Technology Inc., Kittaning, PA) substrates with a double alkoxide precursor synthesized by the method introduced by Gurkovich and Blum.³⁶ In this synthesis, previously assayed lead acetate hydrate, Pb(CH₃COO)₂·3.3H₂O, was placed in a 3-neck flask, fitted with a reflux condenser, and dissolved at 70° C in 2-methoxy ethanol ($T_b = 124$ °C), $C_3H_8O_2$.

Water was removed from lead acetate hydrate by distillation at ~120°C for 1h. After cooling to 70°C, titanium-isopropoxide, Ti(OC₃H₇)₄ was stirred into the solution under nitrogen to produce a composition with a 1:1 Pb:Ti ratio. The solution was then boiled and refluxed for one hour to allow the formation of the Pb-Ti double-alkoxide. A Fourier Transform Nuclear Magnetic Resonance study by Ramamurty and Payne³⁷ has shown that short-chain oligomers, with -Ti-O-Pb- bonds, form during refluxing. The precursor viscosity was adjusted by distilling some of the solvent and the double-alkoxide was stored under nitrogen. No additions were made to stabilize or pre-hydrolyze the precursor. For an assay, 5 ml of the precursor was poured into an alumina crucible and allowed to react with atmospheric moisture. After drying overnight, the gel was heated (5°C/min.) to 600°C for one hour. Gravimetric analysis showed the solution contained 0.55 mols of PbTiO₃. The assayed powder was examined by X-ray diffraction (XDS2000, Scintag Inc., Sunnyvale, CA) using silicon as an internal standard.

Polished, cubic single crystal, (001) oriented SrTiO₃ substrates were used in study. The substrates were cleaned by rinsing in tri-chloro-ethane, acetone and iso-propanol to remove organic contamination. Ultrasonic cleaning was avoided because it was found to cause surface damage, as determined by optical microscopy. After cleaning, the substrates were heated to 1400°C for 2h to remove polishing damage. The annealed substrates were stored in a vacuum-dessicator. Just prior to spin-coating, the double-alkoxide precursor was transferred, under nitrogen, to a pipette. The pipette was fixed in a device above the spin-coater and flushed continuously with nitrogen to prevent premature hydrolysis. After deposition by spin-coating (5000 rpm for 30 s), the films were kept in air for at least 0.5 h to allow the thin alkoxide precursor films to react with atmospheric water, before any heat treatment.

As reported below, lead loss during heat-treatment was found to hinder epitaxy. To minimize lead loss, the specimens were placed in a covered, subdivided alumina boat containing PbO powder. Heat-treatments (5°C/min) at temperatures between 350°C and 800°C were carried out in a tube furnace under flowing (~12 cm³/min) instrument grade oxygen followed by cooling to room temperature at 10°C/min. Specimens heated to temperatures ≥ 450°C were held for one hour at 450°C to ensure complete pyrolysis³0,38 before heating to higher temperatures.

To evaluate the process of crystallization, epitaxy, and microstructural evolution, thin films heat-treated at different temperatures were examined by X-ray diffraction (XDS2000, Scintag Inc., Sunnyvale, CA, and MRD, Philips, Eindhoven, The Netherlands), Atomic Force Microscopy (AFM; Nanoscope III, Digital Instruments Inc., Santa Barbara, Ca), Scanning Electron Microscopy (SEM; JEOL 6300FE, Tokyo, Japan) and Transmission Electron Microscopy (TEM; JEOL 2000FX, 4000FX, 4000EX).

3. Results

3.1 Effect of PbO Environment on Microstructural Development

Heat-treatments of the thin films were initially performed without PbO powder adjacent to the specimens. Lead-loss at heat-treatment temperatures of 500°C - 650°C was found to hinder grain coarsening and the epitaxial phenomena as detailed below. Unidentified Pb-deficient second phases formed at temperatures between 700°C and 800°C and were observed in TEM specimens by energy dispersive spectroscopy. To control lead-loss, all further heat-treatments were carried out with the specimens placed adjacent to PbO powder in a subdivided, covered alumina boat.

3.2 X-ray Diffraction of Powder

A Θ - Θ X-ray diffraction scan of PbTiO₃ powder synthesized from the double-alkoxide precursor and heated to 600 °C/1h showed phase-pure tetragonal PbTiO₃ perovskite with lattice parameters of a_{PTO} = 0.3907 nm and c_{PTO} = 0.413 nm determined with a silicon internal standard. The reason for the small differences between these and literature values³⁹ (a_{PTO} = 0.3904 nm and c_{PTO} = 0.4152 nm) is unknown.

3.3 X-ray Diffraction of Films Heat-Treated in a PbO Environment

0-0 X-ray diffraction scans of the PbTiO3 thin films were performed after maximizing the intensity of the (002) STO substrate reflection (achieved by maximizing intensities in Θ - Θ , ω - (rocking) and χ - (azimuth) scans). For the films heated at temperatures of 450°C and above, only the (001) tetragonal PbTiO₃ reflections were observed; (h00) diffraction peaks were masked by the strong No other reflections for either PbTiO₃ of any other phase were substrate peak. detected. As shown in Fig. 1, the intensity of the (002) reflections strongly increased with increasing heat-treatment temperatures between 450°C/1h to 800°C/1h, consistent with an oriented PTO film (all scans in Fig. 1 were normalized such that the {003} SrTiO₃ substrate reflections were approximately the same intensity for all The intensities of (002) PbTiO₃ reflections of films heated at heat-treatments). 675°C/1h and 800°C/1h were nearly identical, indicating that the apparent orientational quality of the films were similar between these temperatures. Because of the low scattering strength of thin polycrystalline films, X-ray diffraction results from randomly oriented films had to be carefully scrutinized. For example, we were unable to detect any film reflections for specimens heated at temperatures

between 380°C/1h and 420°C/1h, although the presence of a distinct randomly oriented crystalline phase was observed for the same specimens by TEM.

To determine the exact orientation of the ferroelectric domains (twins) in the epitaxial film heated at 800°C/1h, high resolution X-ray diffraction pole figure scans (Philips, MRD) were recorded for the PbTiO₃ (002) and (200) reflections. These scans were limited to a small portion of the hemispherical diffraction space about the Figure 2a shows an intensity-contour plot of the limited pole surface normal. figure for the PbTiO₃ (002) reflection. It shows four specific orientations for the (001) planes of the c-domains (cpto 1 film/substrate interface) in the film, and shows that the c-domains are rotated about <100>STO and <010>STO, away from the substrate normal [001]_{STO}, by approximately 0.7°. The rocking-curve for PTO (002) at psi = -0.3°, as shown in Fig. 2b, can be fit to two over-lapping Gaussians. The full width half maximum (FWHM) of the individual Gaussians is ~ 0.9 and ~ 0.8, respectively. A pole figure scan for PTO (200) is shown in Fig. 2c. It also shows four different orientations for the (h00) planes of the a-domains (cpto || film/substrate interface). The a-domain rotation-angle of ~2.2° about <100>_{STO} and <010>_{STO}. away from the substrate normal [001]_{STO}, is larger than for the c-domains. rocking curve of one of the a-domain orientations at psi = -0.3° and Δ omega = 2.2° shows a similar FWHM of ~ 0.7° (Fig. 2d) as determined for the c-domains.

3.4 SEM of Films Heat-Treated in a PbO Environment

Specimens of films heat-treated between 450°C/1h and 800°C/1h were examined with a field-emission SEM using a 5 kV accelerating voltage. The microstructural development of these films is shown in Fig. 3. At 450°C/1h the film consists of nanometer grains and pores (Fig. 3a). At lower temperatures of 380°C/1h or 420°C/1h, fine scale microstructural features were unresolvable by SEM. Figure 3b shows that after heat-treating at 625°C/1h both pores and grains

have undergone significant coarsening (= 100 nm). Despite its polycrystalline appearance, the Θ - Θ scans shown in Fig. 1 indicate a {001} textured film. At 675°C/1h, Fig. 3c shows residual grains on top of a strongly pitted and faceted film, indicating almost complete epitaxy - this is consistent with the X-ray diffraction pattern shown in Fig. 1. At 800°C/1h, the film is free of facets and residual grains on the surface as shown in Fig. 3d. Large terraces of several microns in size and smaller scale rectangular features corresponding to ferroelectric c- and a-domains (0.1 and 0.3 µm) can be observed. Imaging of ferroelectric domains in the SEM is facilitated by using an accelerating voltage close to the cross-over voltage of the film⁴⁰ (~ 5 kV for PbTiO₃). Voltage contrast is caused by the differently polarized ferroelectric a- and c-domains. This observation is consistent with TEM and AFM results.

3.5 TEM of Films Heat-Treated in a PbO Environment

Figure 4a illustrates that a film heated for one hour at 380°C contains randomly oriented, nanometer grains embedded in an apparently amorphous matrix, as determined with TEM tilting experiments and selected area diffraction (no experiments were performed to determine the length scale of order in the amorphous matrix). Crystallization continues throughout the film until at 400°C/1h the entire layer consists of the randomly oriented grains. SAD of the film heated at 400°C/1h in Fig. 4b shows that the grains have a fluorite structure with a lattice-parameter of a = 0.49 nm. No superlattice reflections, typical for the related pyrochlore structure (Pb₂Ti₂O₆ a = 1nm), could be observed. High resolution TEM (HRTEM) could not establish any particular orientation relationship between the fluorite grains and the substrate.

Continued heating to 420°C/1h initiates a phase transformation from the Pb-Ti-fluorite to tetragonal PbTiO₃ perovskite at the film/substrate interface. The perovskite then grows to consume all of the fluorite phase (Fig. 5). SAD of film and substrate (inset in Fig. 5a) and dark field (DF) imaging with the (020)-substrate/film reflection (Fig. 5b) showed that the perovskite grains were highly $\{001\}^a$ aligned. At 450°C/1h the film has completely transformed to an oriented, porous, tetragonal perovskite with a mosaic spread of ~ 10°.

When heated to 650°C/1h, the mosaic spread was reduced significantly as shown in the inset SAD pattern in Fig. 6a. Residual porosity and ferroelectric domains are shown in Figs. 6a and 6b by bright and dark field TEM, respectively. Dark field imaging with the (002) reflection, containing diffraction information of both film and substrate, suggests that the formation of the epitaxial layer is complete. After heat-treatment at 675°C/1h (Fig. 7), the residual porosity and mosaic spread are greatly reduced, but facets and large residual grains are present on the surface of the film, as shown earlier with SEM (Fig. 3). Surface smoothing by either evaporation-condensation or surface diffusion was achieved for a PbTiO3 film heated at 800°C/1h. Figure 8 illustrates the ferroelectric domain structure and the low threading dislocation density of the films heated at 800°C/1h. No threading dislocations were found over all of the electron transparent area of the cross-section sample. Assuming a volume of $0.1 \times 0.1 \times 50 \,\mu\text{m}$, the threading dislocation density must have an upper limit of $\sim 2 \times 10^7 \,\text{cm}^{-2}$.

Figure 9 illustrates (via HRTEM) that the narrow twins are a-domains (c-axis \parallel film/substrate interface) and the wide twins are c-domains (c-axis \perp film/substrate interface). Strain contrast resulting from misfit dislocations at the interface of c-domains with the substrate can be seen in Fig. 8. A similar contrast can be observed at the intersection of domain boundaries with the substrate. In the latter case, the

a) For simplicity we call the film '{001} oriented'. The actual epitaxial relationship is as follows: (001)[100]PbTiO3||(001)[100]SrTiO3.

contrast stems from interfacial disclinations resulting from the equilibrium tilts in a- and c-domains due to twinning. The relative tilt of approximately 3.5° between a- and c-domains was measured from the orientation of lattice fringes in Fig. 9. Also, the change of the surface orientation of the a-domains as a result of twinning is illustrated in Fig. 9. The morphology associated with surface orientation may be used to image the ferroelectric domains with the Atomic Force Microscope as shown in Fig. 10. The tilts in a- and c-domains could be detected by SAD parallel to [100], as described elsewhere. For a-domains it was found that the relative rotation of [010]pTO (\perp to the film/substrate interface) about <100>pTO and <010>pTO (\perp to the film/substrate normal [001]pTO. For [001]pTO (\perp to the film/substrate interface) of the c-domains a rotation of only p 0.5° from the substrate normal [001]pTO could be detected. These results are in agreement with X-ray pole figure results shown in Fig. 2.

4. Discussion

Cross-sectional TEM characterization showed how a precursor solution processed thin film develops into an epitaxial tetragonal perovskite PbTiO₃ thin film. The sequential steps in this process include: i) the initial crystallization of the amorphous film to a partially dense, nano-crystalline fluorite phase with a smooth surface morphology; ii) the transformation of the fluorite film to a porous, highly {001} textured perovskite film; iii) reduction of the mosaic spread and porosity to produce a single crystal PbTiO₃ thin film with a pitted surface morphology; and iv) the elimination of surface pits at 800°C to produce a smooth and epitaxial PTO thin film.

When the thin films were heat-treated in a furnace without adjacent PbO powder, SEM and X-ray diffraction studies showed that the microstructural

evolution arrested at a stage where the film had a large mosaic spread and contained large pores. Further heat-treatment lead to the formation of uncharacterized second phases with a lower Pb/Ti ratio relative to PbTiO₃.

4.1 Crystallization of the Fluorite Phase

Our study clearly demonstrated that the crystallization of the stoichiometric PbTiO₃ precursor to the perovskite structure occurs through an intermediate fluorite phase. This appears to confirm the observation of an 'unknown intermediate phase' in an early powder X-ray study by Blum and Gurkovich.³⁰ Other researchers^{3,5} have also reported that sputtered PbTiO₃ films crystallize with a fluorite structure at low deposition temperatures.

Because precursors pyrolyze to an inorganic material at low temperatures relative to the melting temperature, the free energy change for crystallization, ΔG_c , is large, and the critical nucleus size required for spontaneous crystallization is small. Thus, the crystallization of a connective (partially sintered) network of nano-crystallites is commonly observed; crystallization typically occurs at temperatures were long-range diffusion is kinetically limited and thus metastable phases often ystallize. 42,43 In the present case, the crystallization of the fluorite phase instead of the thermodynamically stable perovskite is another example of kinetically limited crystallization. Transformation and/or decomposition to more stable structures requires heating to temperatures were long range diffusion becomes kinetically viable.

Metastable crystallization of precursors to fluorite or pyrochlore during synthesis of $Pb(Zr,Ti)O_3$ compositions is commonly observed.⁴⁴ In the current case, a Pb-Ti-fluorite phase with a = 0.49 nm crystallized instead of the structurally related pyrochlore phase. The absence of any superlattice reflections (that would appear for the ordered pyrochlore structure with a = 1.05 nm) confirms an observation by

Wilkinson et al.,31 stating that although the intermediate phase is often called "pyrochlore", superlattice reflections that would indicate the higher degree of order in the pyrochlore were actually rarely reported. A₂B₂O_{7-x} pyrochlores in general can be seen as "2 x 2 x 2" (8 unit cells) fluorites with 8-coordinated A- and 6-coordinated B-cations. 45 Ordering of the oxygen vacencies in the structure cause the doubling of the cell length compared to a regular fluorite. Cation and oxygen vacancy ordering has been observed in the crystallization of non-stoichiometric fluorites when exposed to higher heat-treatment temperatures. For example, Jayaram et al.46 have shown that (Y,Zr)2O3 solid-solutions first crystallize with the fluorite structure because of the random distribution of the oxygen vacancies and then transform to the preferred cubic-rare earth oxide structure at higher temperatures where sufficient diffusion allows vacancy ordering. Similarly, because in the fluorite structure, neither Pb2+ and Ti4+ nor the oxygen vacancies need to order during diffusion limited crystallization, it might be expected that the fluorite would be selected as the metastable phase prior to PbTiO₃ perovskite crystallization. transformation from either the fluorite or pyrochlore to the perovskite structure at higher heat-treatment temperatures requires a reconstruction of the oxygen sites from a simple cubic to a face centered cubic arrangement. In the kinetically limited crystallization of PbTiO₃, the fluorite can thus be considered a more compositionally flexible phase than the perovskite. In this regard it is interesting to note that PZT perovskite, for example, has been reported to accommodate only 2 mol% PbOdeficiency⁴⁷ in equilibrium at 1000°C.

Using the schematic free energy diagram in Fig. 11 to understand diffusion limited crystallization, it can be seen that during crystallization of a *stoichiometric* Pb-Ti-precursor (path 1), the free energy change ΔG_c is large for the formation of the kinetically favored intermediate fluorite phase. The system further lowers its free energy by ΔG_{f-p} during the reconstructive phase transformation to the

thermodynamically stable perovskite. Because of its ability to accommodate disordered oxygen vacancies, the fluorite structure might also be considered to be the more stable structure for the partitionless crystallization of non-stoichiometric compositions (path 2, Fig. 11), as represented by the broader free energy curve of the fluorite phase relative to the perovskite phase shown in Fig. 11. Heat-treatments at higher temperatures allow diffusion and will lead to partitioning of the metastable fluorite into two phases (e.g., PbO + Perovskite-PbTiO₃), driven by a further decrease of the free energy ΔG_p .

The most important cause for non-stoichiometry in the PbO-TiO₂ and PbO-TiO₂-ZrO₂ systems appears to be the loss of lead due to its volatility during heating. Gradual lead-loss causes local non-stoichiometry on the lead-poor side of the PbO-TiO₂ phase diagram and may promote fluorite formation as suggested in Fig. 11. To compensate lead-loss, it has become common practice to use precursors with 5-10 mol% of excess lead^{28,34,35} or, in the case of sputtering, to use targets containing up to 30% excess Pb (or PbO).³ Because lead-loss takes place gradually, lead-rich non-stoichiometric compositions will promote fluorite formation in the early stages of the heat-treatment as suggested in Fig. 11. Therefore it seems advantageous to employ other methods to control the lead-content of the films. Tani et al.⁴⁴, for example, have used a PbO-overcoat on top of PLZT films. In our study, we have successfully employed a Pb-rich atmosphere from PbO during heat-treatment of the stoichiometric precursor films. The PbO vapor pressure over PbO is approximately two orders of magnitude higher than over PbTiO₃ ⁴⁷ and thus prevents lead-loss from the film into the atmosphere.

It also is likely that an increase of the number of species in the system (e.g. PZT compared with PbTiO₃) increases the possibility for global and local non-stoichiometry and thus for fluorite formation. The stronger tendency of Pb(Ti,Zr)O₃ compositions containing Zr to form and retain the fluorite phase has

been widely reported in the literature.^{3,28,30-35,38,44} In an *in-situ* X-ray diffraction study, Wilkenson et al.³¹ have observed fluorite formation for PZT and PbZrO₃ compositions but not for PbTiO₃. However, the chosen time and temperature interval may have missed a fleeting fluorite phase before its transformation to PbTiO₃ perovskite. It has been noted that the tendency of Zr⁴⁺ to be coordinated by more than six oxygens, is more likely to be accommodated by the defect-fluorite structure than the rigid perovskite structure with only 6-coordinated B-cations.³¹ Yamaguchi et al.,⁴⁸ for example, discuss PbZrO₃ as the end member of a fluorite solid-solution series in the PbO - ZrO₂ binary system.

For polycrystalline, as well as epitaxial PZT films, it has been shown that rapid thermal annealing at rates on the order of 100°C/s can minimize or even avoid fluorite formation.^{28,49} It appears that the high heating rate might minimize the density of fluorite nuclei and promote the direct crystallization of the perovskite by moving rapidly to the temperature where long range diffusion is concurrent with crystallization.

4.2 Role of the Fluorite → Perovskite Transformation in the Epitaxy Phenomenon

The observed epitaxy phenomenon of PbTiO₃ on SrTiO₃ is very different than that studied by Miller et al.²⁰ for solution derived cubic-ZrO₂ on cubic-ZrO₂ substrates. Although the initial crystallization was similar to that observed here, namely, the film directly crystallized into partially dense nano-crystalline ZrO₂, two phenomena were very different. First, the ZrO₂ nano-crystallites formed during crystallization had the same structure as the underlying substrate. Second, the nano-crystallites touching the substrate had the same crystallographic orientation as the substrate. It was these oriented crystallites that first grew across the film/substrate interface and then grew up to the film surface to produce a uniform conversion to a single crystal film. The driving force for this conversion was the

free energy change associated with elimination of grain boundary energy per unit volume.

In the current study, the initial polycrystalline film did not have the same structure as the substrate, and the force for the nucleation and growth of the epitaxial grains was different. From the crystallization sequence, it is concluded that the initial crystallization of the metastable fluorite phase selectively promotes the perovskite epitaxy. In systems that directly transform into the final polycrystalline phase, elimination of grain boundary area is the only driving potential for the growth of the epitaxial film. In the case of the PbTiO3 epitaxy, the fluorite to perovskite transformation provides an additional driving potential for epitaxial This phase transformation takes place over a narrow temperature range and it leads to textured PbTiO3 films at 450°C/1h, which is below its ferrroelectric transformation temperature and at ~ 0.4 of its melting temperature. As described above, a relatively small number of perovskite grains with the same orientation as of the substrate were observed to grow through to the film surface and consume the nano-crystalline, metastable fluorite phase. It appeared that this additional driving potential not only allows a few large grains to rapidly grow through the polycrystalline film, but also leads to entrapped porosity within the growing, Thus, the higher driving potential for converting the epitaxial grains. polycrystalline film of one phase into an epitaxial film of a second phase appears to be, in-part, responsible for entrapped porosity and the less ordered growth of the single crystal thin film.

4.3 Film Densification, Mosaic Spread and Surface Pitting

The large mosaic spread in the initially crystallized perovskite phase cannot be attributed to mosaic spread in the STO substrate but rather must be a consequence of the growth process. Since the transforming perovskite grains are growing into a

partially dense polycrystalline fluorite matrix (which is also densifying during the phase transformation), it can be expected that each growing perovskite grain may be rotated, by a small amount, through differential densification. Differential densification of a powder matrix is common in composite systems and produces rotations of individual grains and groups of grains.⁵⁰ In the current case, the growing perovskite grains can be considered as the inclusions (or reinforcements) within the low density matrix.

The entrapped pores coarsen when the films are heat-treated at higher temperatures (Fig. 6b). After heating to temperatures in excess of 675°C/1h, the pores disappeared from within the epitaxied film and the surface becomes pitted (Fig. 7). Since pore disappearance requires material transport form the surface to the pore, or conversely, vacancy transport from the pore to the surface, it is obvious that the pits on the surface are the displaced pores from within the film. Heating to 800° C/1h (T = 0.69 T_{melting} of PbTiO₃) is required to produce sufficient long-range surface mass-transport to form an epitaxial film with a smooth surface as shown in Figs. 8 and 9.

4.4 Shear Strain Between Domains and Constraining Substrate

Although highly oriented PbTiO₃ thin films were formed at $450\,^{\circ}\text{C}/1\text{h}$, below the Curie temperature of $T_{\text{C}} = 490\,^{\circ}\text{C}$, the growth of high quality epitaxial films required heat-treatments at $800\,^{\circ}\text{C}/1\text{h}$. Above T_{C} , PbTiO₃ has a cubic structure and it transforms to the tetragonal structure during cooling through T_{C} . At $800\,^{\circ}\text{C}$ an inplane, unrelaxed linear strain of ~1% would exist between the SrTiO₃ substrate and the cubic PbTiO₃ phase. Misfit dislocations are generally assumed to accommodate much of this strain. The accommodation of mismatch strain by dislocations causes the film not to become strained to the cubic substrate lattice parameter a_{STO} , but rather to the 'effective substrate lattice parameter' a_{STO} , where a_{STO} is the substrate

lattice parameter, asto, modified by misfit dislocations as suggested by Speck and Pompe⁵¹. At 800°C, for cubic paraelectrc PbTiO₃ (a_{PTO} = 0.3975 nm) on cubic SrTiO₃ (asto = 0.3938 nm), asto is smaller than apto and it follows that asto < asto * < apto.Additional strain is produced during cooling through the Curie temperature when the paraelectric (cubic) structure transforms to the ferroelectric (tetragonal) structure. The relaxation of this additional strain occurs by the formation of a- and c-domains. Domain formation was first recognized by Roitburd⁵² to be a means of strain relaxation in heteroepitaxial ferroelectric and ferroelastic films. In order to predict the stable domain configuration for a given substrate/film heteroepitaxial combination, Speck and Pompe⁵¹ developed a temperature dependent domain stability map, incorporating the influence of i) lattice mismatch; ii) thermal expansion mismatch; iii) cooling rate; and iv) depolarizing fields. The schematic map for the dislocation free transformation for STO/PTO is shown in Fig. 12. It shows that with asto < apro and asto < asto * < apro a mixed c/a/c-domain pattern can be expected as confirmed by the observations in the current study. A mixed domain structure should be favored due to the differential thermal expansion coefficient⁵³ ($\alpha_{PTO} = 12.6 \times 10^{-6}$ /K above 490°C and $\alpha_{STO} = 11 \times 10^{-6}$ /K (20°C -1000°C)). Although no cooling rate experiments were conducted in this study, a high cooling rate of ~ 30°C/min or higher can be expected,⁵³ and has been observed, 9,11 to enhance the formation of c-domains.

During the formation of c- and a-domains, the c-axis of the c-domains has to coherently fit to the a-axis in an a-domain. This is only possible if an equilibrium angle between the two domains is maintained. Using the room-temperature PbTiO₃ c/a ratio, the angle is calculated to be 3.55°, provided that there are no constraints from the substrate.⁴¹ As observed by SAD, HRTEM (Fig. 9) and in high resolution X-ray diffraction pole figures (Fig. 2), both c-domains and a-domains are rotated about <100>_{STO} and <010>_{STO}, away from the [001]_{STO} substrate normal. For

the epitaxial PbTiO₃ films on SrTiO₃, the lattice match of the c-domains with the substrate is much better than for the a-domains (apro = 0.3904 nm, cpro = 0.4152 nm, asro = 0.3905; at room temperature). Because it is observed that the volume fraction of c-domains is larger than that of a-domains, it becomes a geometrical necessity to have small rotations on the order of $\sim 0.7^{\circ}$ of the c-domains and larger rotations of $\sim 2.2^{\circ}$ of the a-domains (Fig. 2; X-ray diffraction measurements were used here because TEM only samples a small area of the specimen). These results are described in detail by Daykin et al.⁴¹ For both, c- and a-domains, Ω -scans (Fig. 2b,d) showed the FWHM to be only about 0.8° and 0.7°, respectively.

5. Conclusions

A double-alkoxide liquid precursor was used to form epitaxial single crystal PbTiO3 thin films on SrTiO3. Lead-loss during processing was successfully avoided by heating in a PbO containing atmosphere. Cross-section TEM showed that the formation of the epitaxial PbTiO3 thin films occurs through an intermediate polycrystalline Pb-Ti-fluorite phase. The concept of kinetically limited crystallization was applied to the formation of the metastable Pb-Ti-fluorite phase. Free energy considerations showed that the initial crystallization of the fluorite may be advantageous to obtain highly oriented PbTiO3 films at low temperatures (~450°C/1h). However, initial fluorite formation may also encourage entrapped porosity, and thus lead to higher processing temperatures for formation of smooth, epitaxial films. A pattern of a- and c-domains was observed and their relative, small rotations about <100>STO and <010>STO were determined by TEM and X-ray diffraction.

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Figure Captions

- Fig. 1: X-ray diffraction Θ - Θ scans on PbTiO₃ thin films heated at different temperatures. The intensity of the (00l) reflections increases strongly as the heat-treatment temperature is raised from 450°C/1h to 800°C/1h and indicates the development of epitaxy.
- Fig. 2: a) High resolution pole figure scan on (002) of a PbTiO₃ film heated at 800° C/1h. Four different c-domain orientations can be seen. The rotation about <100>STO and <010>STO is ~ 0.7° from the substrate normal [001]STO.
- b) The Ω -scan on the c-domains can be fit to two overlapping Gaussians. The FWHM of the individual Gaussians is ~ 0.9 and ~ 0.8, respectively.
- c) High resolution pole figure scan on (200) of the PbTiO₃ film. Four different a-domain orientations can be seen. The rotation about <100>STO and <010>STO is ~ 2.2° from the substrate normal [001]STO.
- d) Ω -scan on one of the a-domain orientations at psi = -0.3° and Δ omega = 2.2°. The FWHM for the a-domains is ~ 0.7°.
- Fig. 3: SEM on films heated at different temperatures (see X-ray diffraction in Fig. 1). A nanocrystalline film at 425°C/1h (a) coarsens and densifies as seen at 625°C/1h (b). Faceting at 675°C/1h (c) indicates epitaxy and at 800°C/1h (d) a smooth film surface showing ferroelectric domains that are imaged by voltage contrast.
- Fig. 4: a) BF TEM of a film heated at ~380°C/1h. Nucleation of a Pb-Ti-phase with a fluorite structure (see 4b) with a=0.49 nm. The inset SAD pattern shows an amorphous ring from the matrix as well as reflections from the Pb-Ti-fluorite.

- b) SAD of the film at ~400°C/1h showing that the film consists primarily of the polycrystalline Pb-Ti-fluorite.
- Fig. 5: a) BF TEM of a film heated at ~420°C/1h. Starting at the interface, polycrystalline Pb-Ti-fluorite transforms into a highly {001} textured tetragonal perovskite that consumptively grows through the fluorite to the film surface.
- b) SAD and DF TEM with the (020)-substrate/film reflection shows that the tetragonal perovskite is highly (001) textured with a large mosaic spread.
- Fig. 6: a) BF TEM. At 650°C/1h the film has undergone significant coarsening and concurrent decrease of mosaic spread (see inset SAD pattern). Ferroelectric domains as well as residual pores can be seen in the film.
- b) DF TEM using a substrate/film reflection showing completion of oriented layer formation.
- Fig. 7: BF TEM image of a completely epitaxial, faceted film of a specimen heated at 675°C/1h. As suggested by SEM, large residual grains of similar orientation (TEM) remain at the film surface.
- Fig. 8: At 800°C/1h the surface has become smooth by evaporation/condensation or surface diffusion. The film has a low threading dislocation density and shows strain contrast from disclinations at the domain-boundary/interface intersections and misfit dislocations in c-domains.
- Fig. 9: HRTEM image of the film in Fig. 8, heated at 800°C/1h. Narrow adomains (c) interface) and wide c-domains (c) interface) can be seen. The

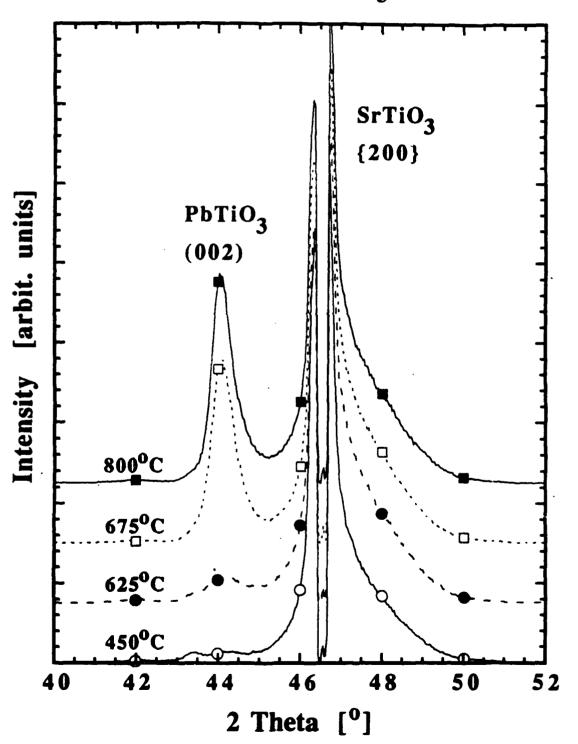
twinning angle between a- and c-domains as well as the resulting change in surface orientation can be observed.

Fig. 10: AFM on the film heated at 800°C/1h allows to image the ferroelectric domain structure due to the change in surface orientation as a result of twinning.

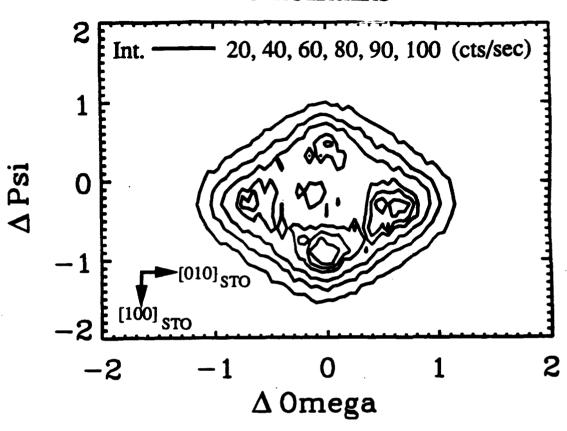
Fig. 11: Schematic free energy diagram of the system PbO-TiO₂ showing the relative free energy curves for the amorphous precursor, fluorite, and perovskite phases. Path 1 gives the crystallization sequence for a stoichiometric precursor and Path 2 illustrates the sequence for a non-stoichiometric composition.

Fig. 12: Coherent domain stability map for SrTiO₃/PbTiO₃. It shows that with $a_{STO} < a_{PTO}$ and $a_{STO} < a_{STO}^* < a_{PTO}$, a c/a/c-domain pattern can be expected.⁵¹

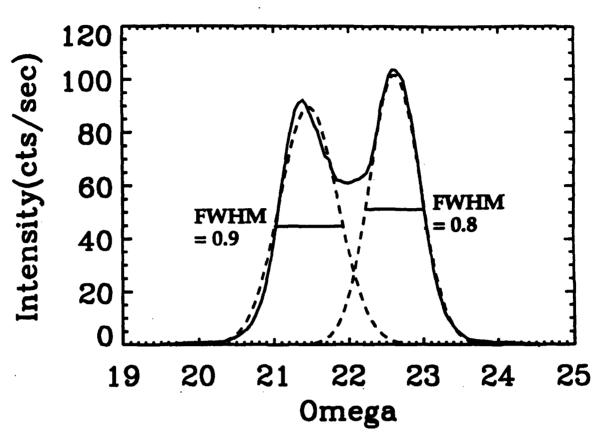
X-ray Data for PbTiO₃ Thin Films



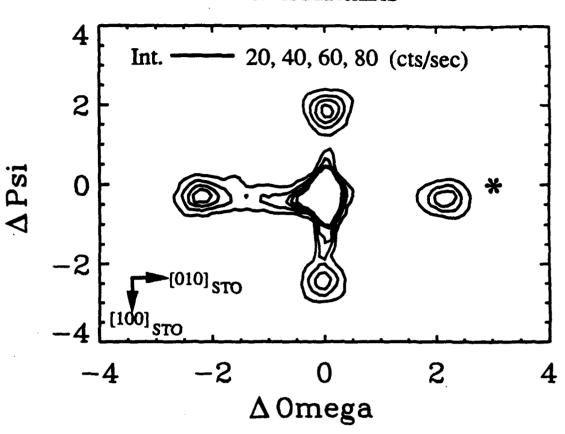
c-domains

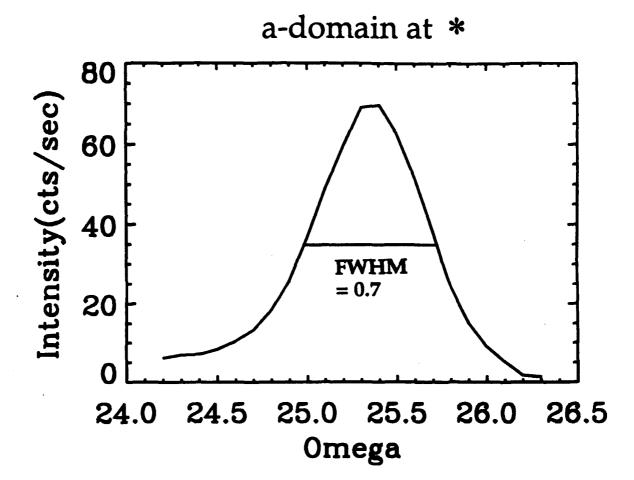


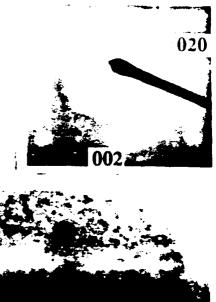




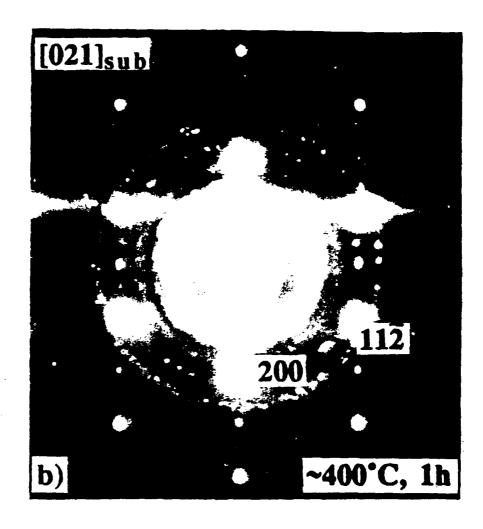
a-domains



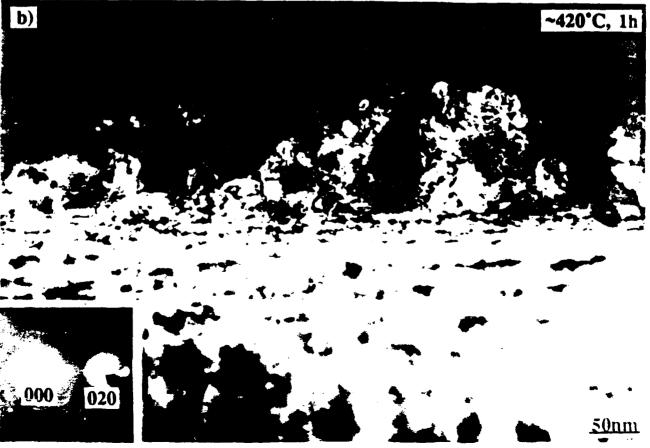


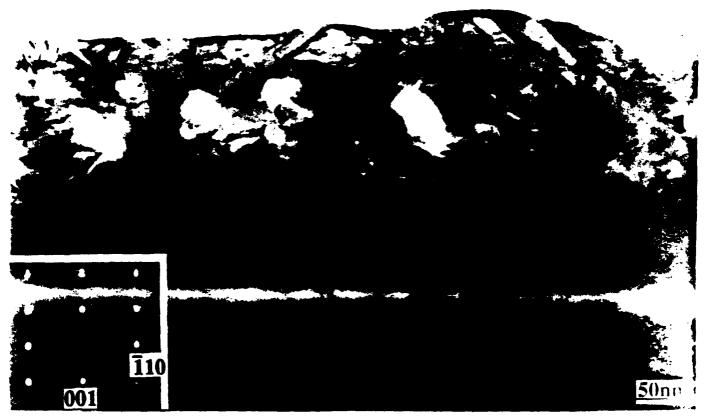


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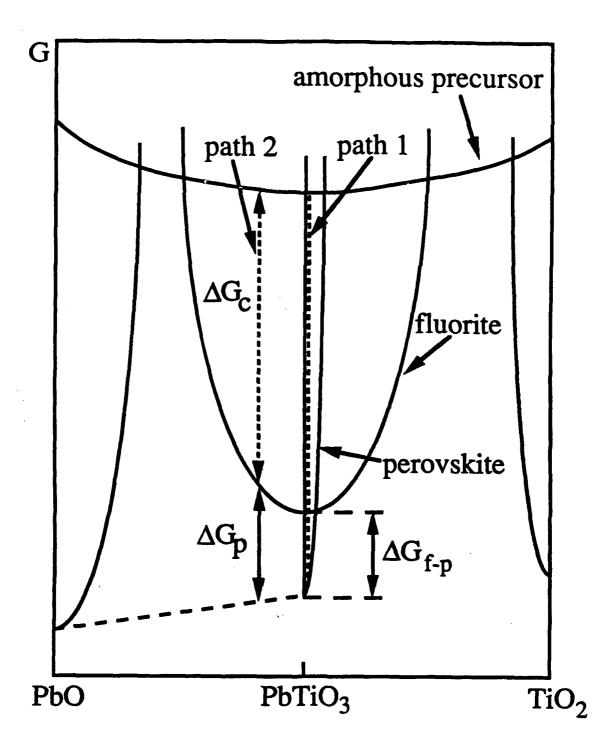
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800°C, 111

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Temperature, °C